适用于隔离电源的 SN6505x-Q1 低噪声 1A 变压器驱动器

1 特性

- 符合面向汽车应用的 AEC-Q100（1 级）标准
  - 器件温度等级 1：–40°C 至 +125°C，T_A
- 提供功能安全
  - 可提供用于功能安全系统设计的文档：SN6505A-Q1，SN6505B-Q1，SN6505D-Q1
- 用于变压器的推挽式驱动器
- 宽输入电压范围：2.25V 至 5.5V
- 高输出驱动：5V 电源下为 1A
- 低 R_{ON}，4.5V 电源时的最大值为 0.25Ω
- 降低了传导和辐射 EMI
- 扩频时钟
- 精密内部振荡器选项：160kHz (SN6505A-Q1) 和 420kHz (SN6505B-Q1 和 SN6505D-Q1)
- 通过外部时钟输入同步多个器件
- 转换率控制
- 1.7A 限流
- 低关断电流：< 1 μA
- 热关断
- 小型 6 引脚 SOT23 (DBV) 封装
- 启用软启动（SN6505A-Q1 和 SN6505B-Q1）可减小浪涌电流，禁用软启动 (SN6505D-Q1) 可实现快速启动

2 应用

- 用于以下应用的隔离式电源：
  - 牵引逆变器和电机控制
  - 直流/直流转换器
  - 电池管理系统 (BMS)
  - 车载充电器 (OBC)

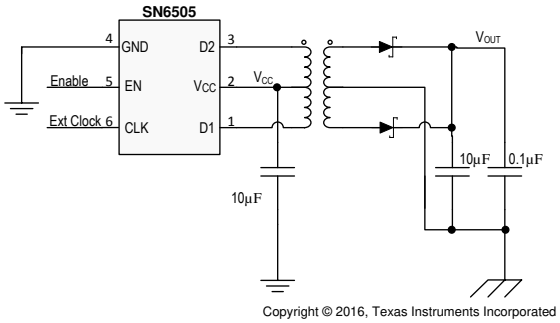
3 说明

SN6505x-Q1 是一款低噪声、低 EMI 的推挽式变压器驱动器，专为小型隔离式电源而设计。该器件通过 2.25V 至 5V 的直流电源来驱动薄型、中间抽头的变压器。通过输出开关电压的转换速率控制和扩频时钟 (SSC) 可实现非常低的噪声和 EMI。SN6505x-Q1 包含一个振荡器，然后是一个栅极驱动器电路，此电路提供补偿输出信号以驱动接地参考 N 通道电源开关。该器件包含两个 1A 电源 MOSFET 开关，以确保在重负载条件下正常启动。开关时钟也可由外部提供，以准确放置开关谐波或者在与多个变压器驱动器搭配工作时。内部保护特性包括 1.7 A 限流、欠压锁定、热关断和先断后合电路。SN6505A-Q1 和 SN6505B-Q1 具有软启动功能，可防止大负载电容器在上电过程中出现高浪涌电流。对于需要快速输出启动的应用，SN6505D-Q1 中禁用了软启动功能。SN6505A-Q1 有 160kHz 内部振荡器，适用于需要大幅降低辐射的应用；而 SN6505B-Q1 和 SN6505D-Q1 有 420kHz 内部振荡，适用于需要更高效率和更小变压器尺寸的应用。SN6505x-Q1 采用小型 6 引脚 SOT23/DBV 封装。该器件的运行温度范围为 -40°C 至 125°C。

器件信息

器件型号 (1)	封装	封装尺寸（标称值）
SN6505A-Q1	SOT23（6 引脚）	2.90mm × 1.60mm
SN6505B-Q1		
SN6505D-Q1		

(1) 要了解所有可用封装，请参见数据表末尾的可订购产品附录。



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简化版原理图

本文档旨在为方便起见，提供有关 TI 产品中文版本的信息，以确认产品的概要。有关适用的官方英文版本的最新信息，请访问 www.ti.com，其内容始终优先。TI 不保证翻译的准确性和有效性。在实际设计之前，请务必参考最新版本的英文版本。

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4 Revision History

Changes from Revision C (August 2019) to Revision D (October 2020) — **Page**

- 添加了“功能安全”要点 1

Changes from Revision B (July 2019) to Revision C (August 2019) — **Page**

- Added UNIT V to EN, CLK Voltage specification in **Absolute Maximum Ratings** table 4
- Changed '<' or 'less than' sign to '≤' or 'less than or equal' sign in V_{CC} range description at multiple location for better clarity 5
- Added **Revision History** comments for data sheet Revision B 6
- Added 'Power up time' or t_{PWRUP} specification for two V_{CC} TEST CONDITIONS 6

Changes from Revision A (April 2019) to Revision B (July 2019) — **Page**

- Split 'Soft-start time' or t_{SS} specification for SN6505A-Q1 and SN6505B-Q1 6

Changes from Revision * (November 2018) to Revision A (April 2019) — **Page**

- 将器件状态更改为“量产数据” 1
- Added DA2303-AL transformer to 表 9-3 table 25
- Added DA2304-AL transformer to 表 9-3 table 25

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5 Pin Configuration and Functions

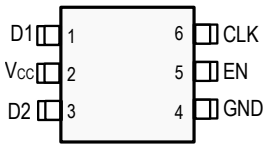

图 5-1. DBV Package SOT-23 (6 Pin) Top View

表 5-1. Pin Functions

PIN			DESCRIPTION
NAME	NO.	TYPE	
D1	1	O	Open drain output of the first power MOSFETs. Typically connected to the outer terminals of the center tap transformer. Because large currents flow through these pins, their external traces should be kept short.
V_{CC}	2	P	This is the device supply pin. It should be bypassed with a 4.7 μF or greater, low ESR capacitor. When $V_{CC} \leq$ 2.25 V, an internal undervoltage lockout circuit trips and turns both outputs off.
D2	3	O	Open drain output of the second power MOSFETs. Typically connected to the outer terminals of the center tap transformer. Because large currents flow through these pins, their external traces should be kept short.
GND	4	P	GND is connected to the source of the power MOSFET switches via an internal sense circuit. Because large currents flow through it, the GND terminals must be connected to a low-inductance quality ground plane.
EN	5	I	The EN pin turns the device on or off. Grounding or leaving this pin floating disables all internal circuitry. If unused this pin should be tied directly to V_{CC}.
CLK	6	I	This pin is used to run the device with external clock. Internally it is pulled down to GND. If valid clock is not detected on this pin, the device shifts automatically to internal clock.

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1). All typical values are at T_A = 25°C, V_{CC} = 5 V.

		MIN	MAX	UNIT
Supply voltage (2)	V_{CC}	–0.5	6	V
Voltage	EN, CLK	–0.5	V_{CC} + 0.5(3)	V
Output switch voltage	D1, D2		16	V
Peak output switch current	$I_{(D1)Pk}$, $I_{(D2)Pk}$		2.4	A
Junction temperature, T_J		-40	150	°C
Storage temperature range, T_{stg}		–65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under 节 6.3 is not implied. Exposure to absolute-maximum-rated conditions for extended periods affects device reliability.
(2) All voltage values except differential I/O bus voltages are with respect to the local ground terminal (GND) and are peak voltage values.
(3) Maximum voltage must not exceed 6V. A strongly driven EN or CLK input signal can weakly power the floating V_{CC} via an internal protection diode and cause undetermined output.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002(1) HBM ESD Classification Level 3A	±6000	V
		Charged-device model (CDM), per AEC Q100-011 CDM ESD Classification Level C6	±1500	

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

			MIN	TYP	MAX	UNIT
V_{CC}	Supply voltage		2.25		5.5	V
I_{D1}, I_{D2}	Output switch current - Primary side	2.25 V ≤ V_{CC} ≤ 2.8 V			0.75	A
		2.8 V < V_{CC} ≤ 5.5 V			1	
T_A	Ambient temperature		–40		125	°C

6.4 Thermal Information

THERMAL METRIC(1)		SN6505x-Q1 DBV (SOT-23) 6 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	137.7	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	57.7	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	46.0	°C/W
ψ_{JT}	Junction-to-top characterization parameter	13.4	°C/W
ψ_{JB}	Junction-to-board characterization parameter	44.9	°C/W
$R_{\theta JC(bottom)}$	Junction-to-case(bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.

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6.5 Electrical Characteristics

over full-range of recommended operating conditions, unless otherwise noted. All typical values are at T_A = 25°C, V_{CC} = 5 V.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
VOLTAGE SUPPLY						
$I_{(Vcc)}$	Supply Current (2.8 V ⩽ V_{CC} ⩽ 5.5 V) (SN6505A-Q1)	R_L = 50 Ω		1	1.4	mA
	Supply Current (2.8 V ⩽ V_{CC} ⩽ 5.5 V) (SN6505B-Q1 and SN6505D-Q1)	R_L = 50 Ω		1.56	2.3	mA
I_{IH}	Leakage Current on EN and CLK pin	EN / CLK = V_{CC}		10	20	µA
I_{DIS}	V_{CC} current for EN = 0			0.1		µA
$I_{LKG(D1)}$ $I_{LKG(D2)}$	Leakage Current on D1, D2 for EN=0	Voltage of D1, D2 = V_{CC}		0.1		µA
$V_{CC+ (UVLO)}$	Positive-going UVLO threshold				2.25	V
$V_{CC- (UVLO)}$	Negative-going UVLO threshold		1.7			V
$V_{HYS (UVLO1)}$	UVLO threshold hysteresis			0.3		V
$V_{IN(ON)}$	EN, CLK pin logic high threshold				0.7	V_{CC}
$V_{IN(OFF)}$	EN, CLK pin logic low threshold		0.3			V_{CC}
$V_{IN(HYS)}$	EN, CLK pin threshold hysteresis			0.2		V_{CC}
CLK						
F_{SW}	D1, D2 average switching Frequency (SN6505A-Q1)	R_L = 50 Ω to V_{CC}; Refer to 图 7-3	138	160	203	Khz
	D1, D2 average switching Frequency (SN6505B-Q1 and SN6505D-Q1)	R_L = 50 Ω to V_{CC}; Refer to 图 7-3.	363	424	517	kHz
$F_{(EXT)}$	External clock frequency on CLK pin (SN6505A-Q1)		100		600	kHz
	External clock frequency on CLK pin (SN6505B-Q1 and SN6505D-Q1)		100		1600	kHz
OUTPUT STAGE						
DMM	Average ON time mismatch between D1 and D2	R_L = 50 Ω		0%		
$R_{(ON)}$	Output switch on resistance	V_{CC} = 4.5 V, I_{D1}, I_{D2} = 1 A		0.16	0.25	Ω
		V_{CC} = 2.8 V, I_{D1}, I_{D2} = 1 A		0.19	0.31	Ω
		V_{CC} = 2.25 V, I_{D1}, I_{D2} = 0.5 A		0.21	0.45	Ω
$V_{(SLEW)}$	Voltage slew rates on D1 and D2 for SN6505A-Q1	R_L = 50 Ω to V_{CC}; Refer to 图 7-3		48		V/µs
$I_{(SLEW)}$	Current slew rates at D1 and D2 for SN6505A-Q1	R_L = 5 Ω through transformer; Refer to 图 7-4		11		A/µs
$V_{(SLEWHF)}$	Voltage slew rates on D1 and D2 for SN6505B-Q1 and SN6505D-Q1	R_L = 50 Ω to V_{CC}; Refer to 图 7-3		152		V/µs
$I_{(SLEWHF)}$	Current slew rates at D1 and D2 for SN6505B-Q1 and SN6505D-Q1	R_L = 5 Ω through transformer; Refer to 图 7-4		41		A/µs
I_{LIM}	Current clamp limit (2.8 V < V_{CC} ⩽ 5.5V)		1.42	1.75	2.15	A
	Current clamp limit (2.25 V ⩽ V_{CC} ⩽ 2.8 V)		0.65		1.85	A
THERMAL SHUT DOWN						
T_{SD+}	T_{SD} turn on temperature		154	168	181	°C
T_{SD-}	T_{SD} turn off temperature		135	150	166	°C
T_{SD-}	T_{SD} hysteresis		13	17		°C

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6.6 Timing Requirements

			MIN	NOM	MAX	UNIT
CLK						
$t_{CLKTIMER}$	Duration after which device switches to internal clock in case of invalid external clock		10		25	µs
OUTPUT STAGE						
t_{BBM}	Break-before-make time(SN6505A-Q1)	Measured as voltage with R_L = 50 Ω to V_{CC}, Refer to 图 7-3		115		ns
	Break-before-make time (SN6505B-Q1 and SN6505D-Q1)	Measured as voltage with R_L = 50 Ω to V_{CC}, Refer to 图 7-3		90		ns
SOFT-START ENABLED (SN6505A-Q1 AND SN6505B-Q1)						
t_{SS}	Soft-start time (SN6505A-Q1)	10% to 90% transition time on V_{OUT} With transformer C_{LOAD} = 40 µF R_L = 5 Ω	1	2.2	8	ms
	Soft-start time (SN6505B-Q1)	10% to 90% transition time on V_{OUT} With transformer C_{LOAD} = 40 µF R_L = 5 Ω	1	4.25	8	ms
$t_{SSdelay}$	Soft-start time delay	From power up to 90% transition time on V_{OUT} With transformer C_{LOAD} = 40 µF R_L = 5 Ω	3.5	8.5	18	ms
SOFT-START DISABLED (SN6505D-Q1)						
t_{PWRUP}	Power up time	From EN=1 to full drive-current available at D1 and D2; 2.25 V ≤ V_{CC} < 3 V		75	160	µs
		From EN=1 to full drive-current available at D1 and D2; 3 V ≤ V_{CC} ≤ 5.5 V		60	100	µs
t_{PWRDN}	Power down time	From EN=0 to output MOSFETs off (no current on D1 and D2)		1	5	µs

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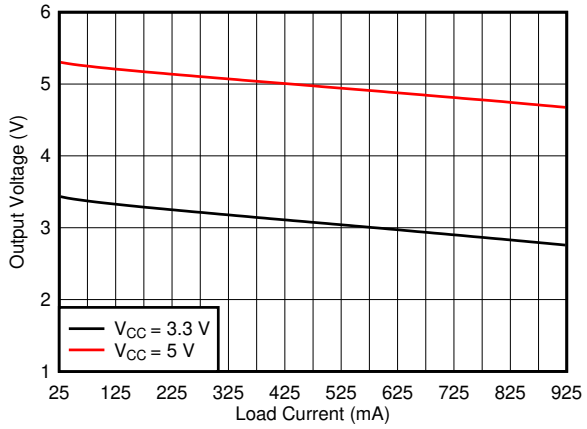
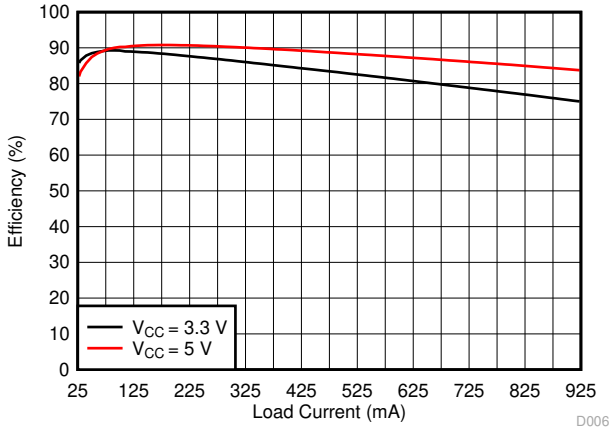
6.7 Typical Characteristics, SN6505A-Q1



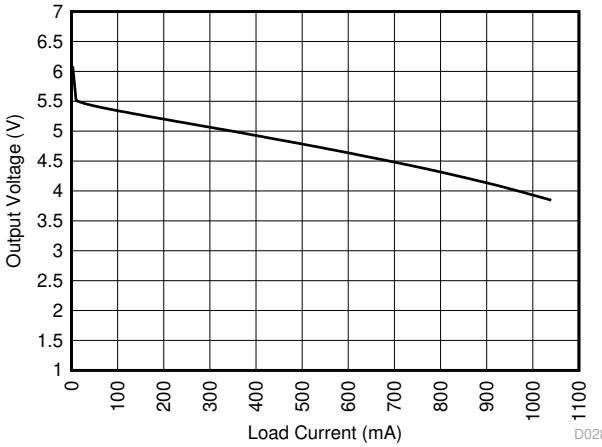
SN6505A-Q1 + Wurth 750315240

图 6-1. Output Voltage vs Load Current



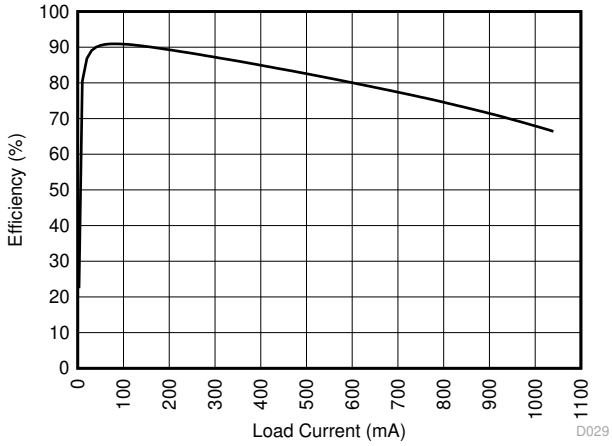
SN6505A-Q1 + Wurth 750315240

图 6-2. Efficiency vs Load Current



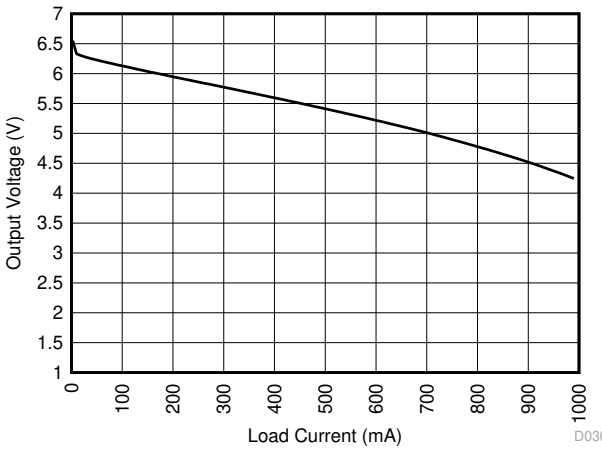
SN6505A-Q1 + Wurth 750316031 V_{CC} = 3.3 V

图 6-3. Output Voltage vs Load Current



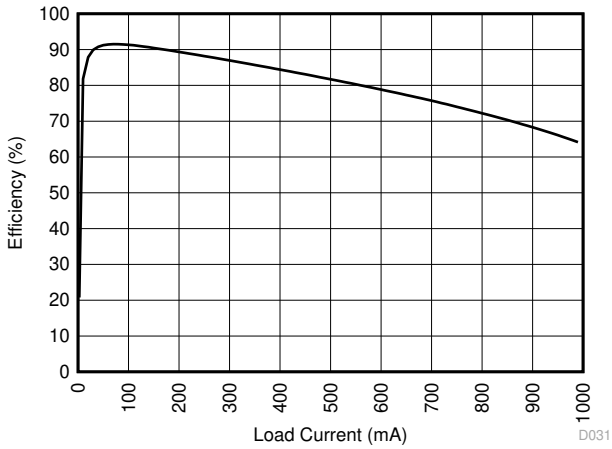
SN6505A-Q1 + Wurth 750316031 V_{CC} = 3.3 V

图 6-4. Efficiency vs Load Current



SN6505A-Q1 + Wurth 750316032 V_{CC} = 3.3 V

图 6-5. Output Voltage vs Load Current



SN6505A-Q1 + Wurth 750316032 V_{CC} = 3.3 V

图 6-6. Efficiency vs Load Current

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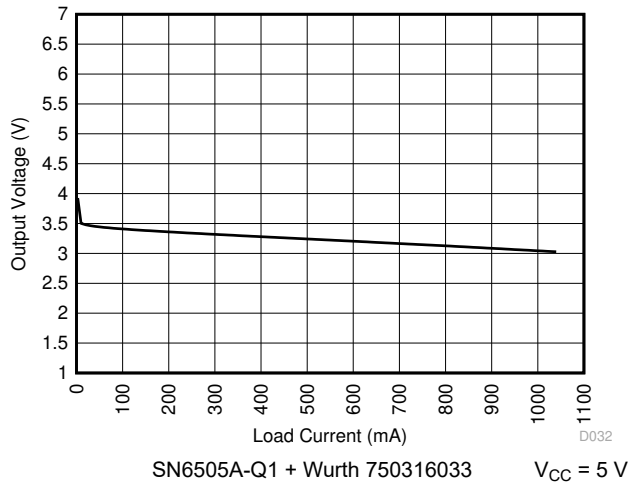

图 6-7. Output Voltage vs Load Current

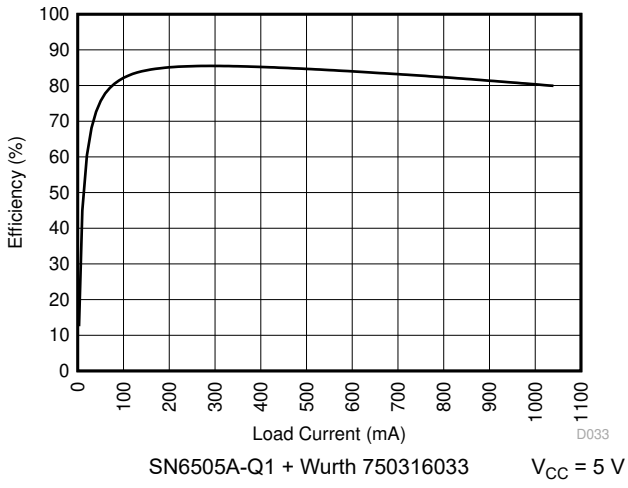

图 6-8. Efficiency vs Load Current

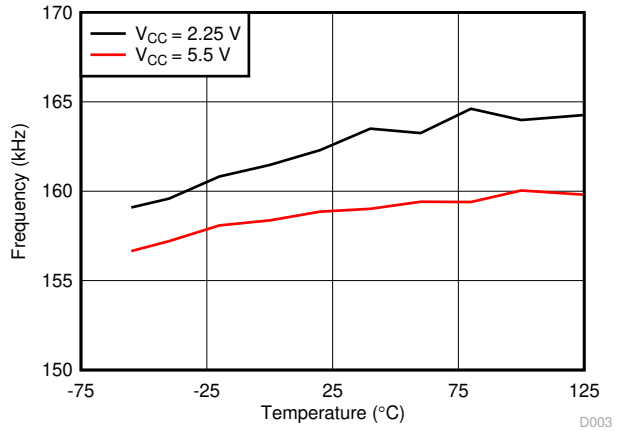

图 6-9. Frequency vs Free-Air Temperature

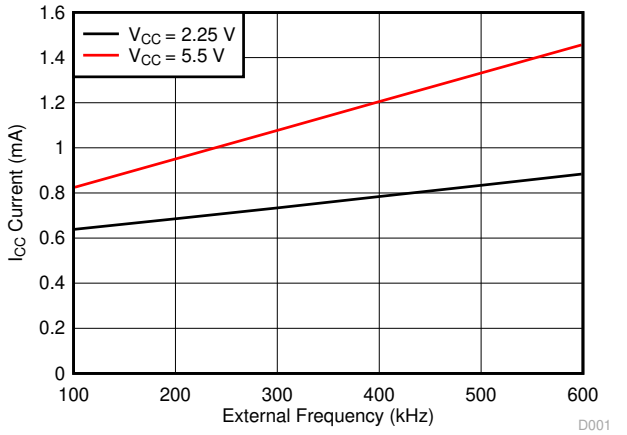

图 6-10. Current vs External Frequency

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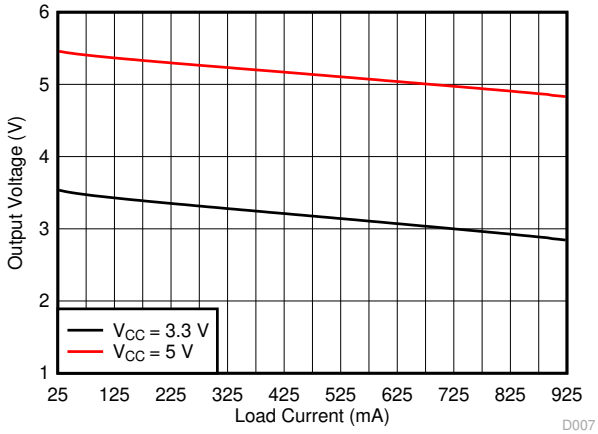
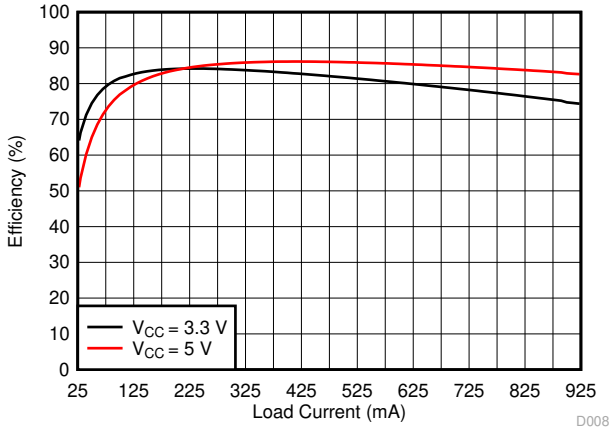
6.8 Typical Characteristics, SN6505B-Q1 or SN6505D-Q1



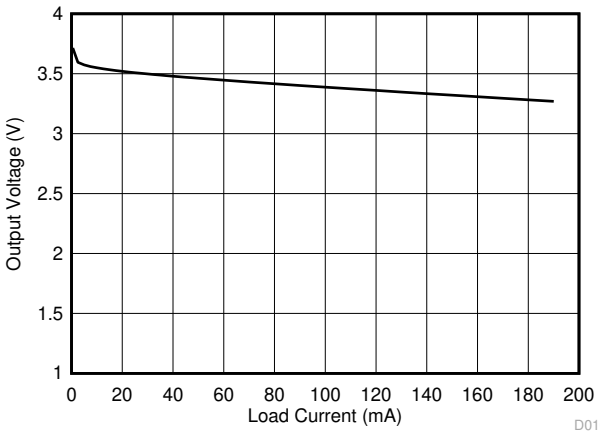
SN6505B/D-Q1 + Wurth 750315371

图 6-11. Output Voltage vs Load Current



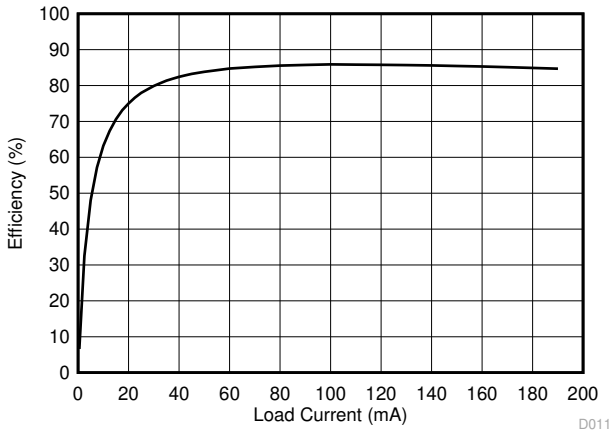
SN6505B/D-Q1 + Wurth 750315371

图 6-12. Efficiency vs Load Current



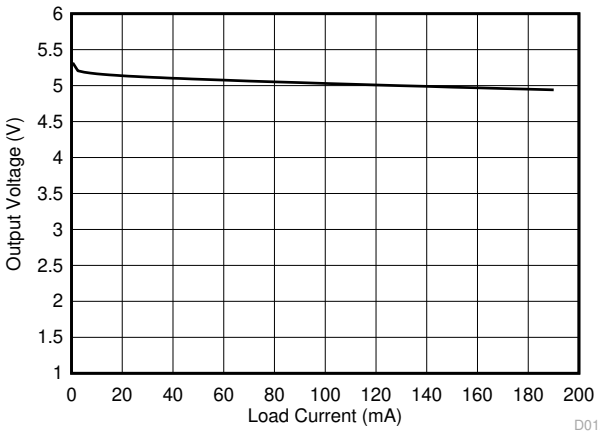
SN6505B/D-Q1 + Wurth 760390011 V_{CC} = 3.3 V

图 6-13. Output Voltage vs Load Current



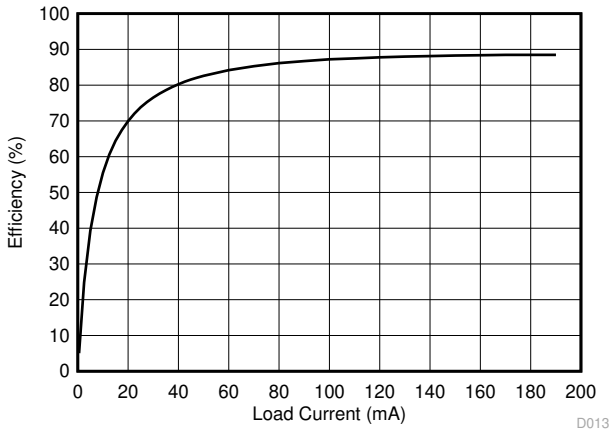
SN6505B/D-Q1 + Wurth 760390011 V_{CC} = 3.3 V

图 6-14. Efficiency vs Load Current



SN6505B/D-Q1 + Wurth 760390012 V_{CC} = 5 V

图 6-15. Output Voltage vs Load Current



SN6505B/D-Q1 + Wurth 760390012 V_{CC} = 5 V

图 6-16. Efficiency vs Load Current

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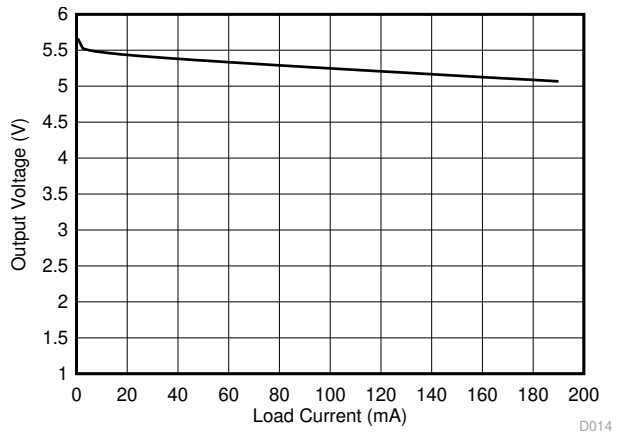
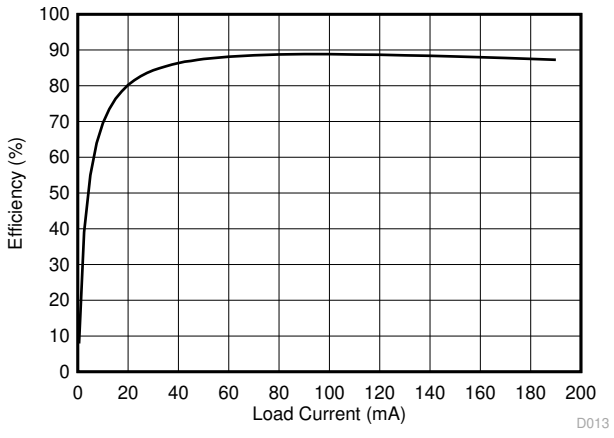


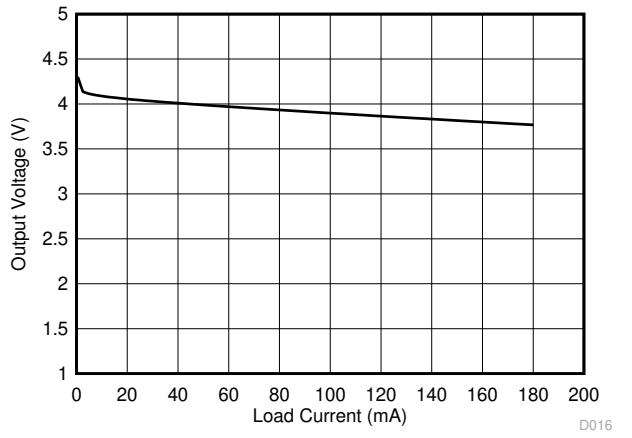
SN6505B/D-Q1 + Wurth 760390013 V_{CC} = 3.3 V

图 6-17. Output Voltage vs Load Current



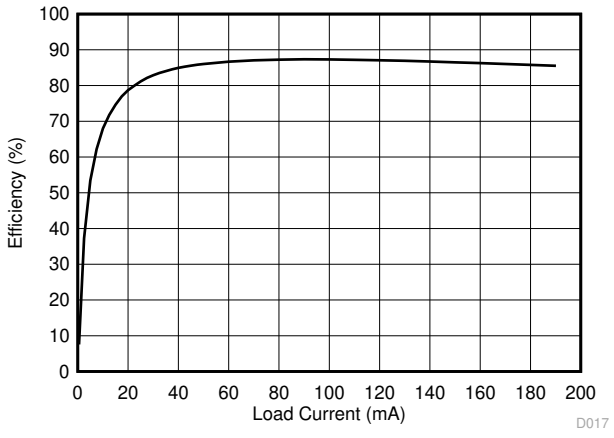
SN6505B/D-Q1 + Wurth 760390013 V_{CC} = 3.3 V

图 6-18. Efficiency vs Load Current



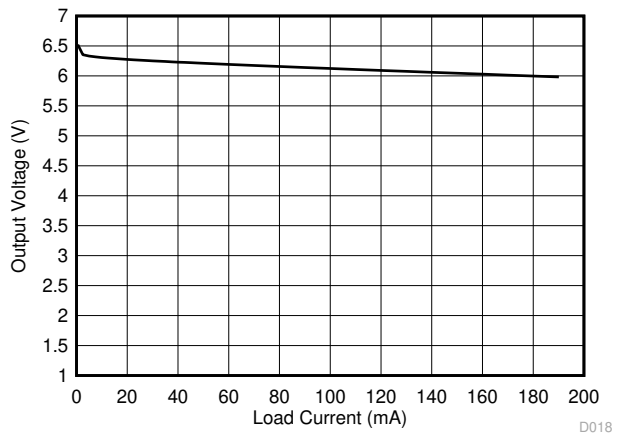
SN6505B/D-Q1 + Wurth 760390014 V_{CC} = 3.3 V

图 6-19. Output Voltage vs Load Current



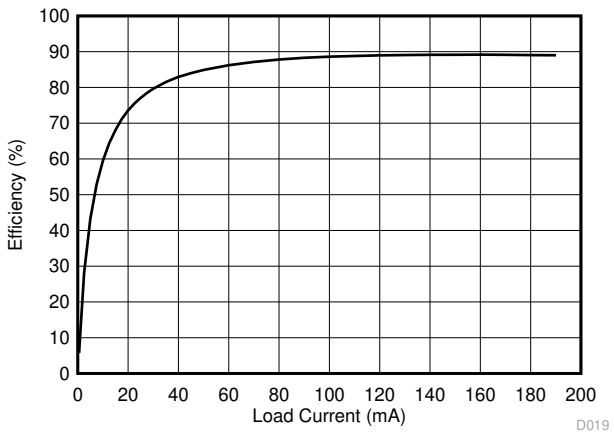
SN6505B/D-Q1 + Wurth 760390014 V_{CC} = 3.3 V

图 6-20. Efficiency vs Load Current



SN6505B/D-Q1 + Wurth 760390014 V_{CC} = 5 V

图 6-21. Output Voltage vs Load Current



SN6505B/D-Q1 + Wurth 760390014 V_{CC} = 5 V

图 6-22. Efficiency vs Load Current

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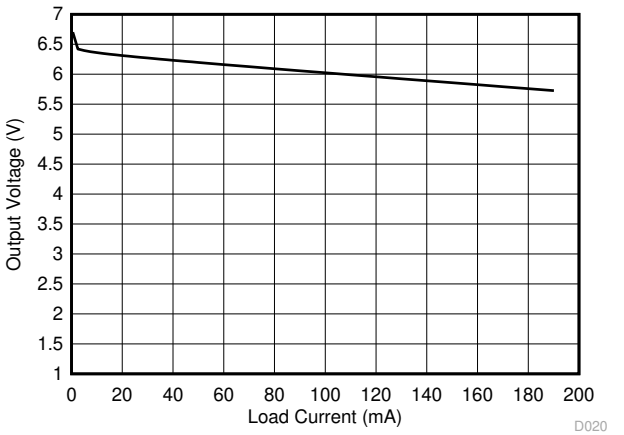
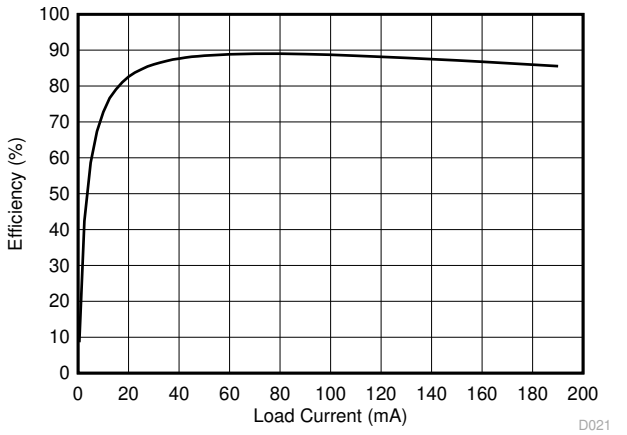


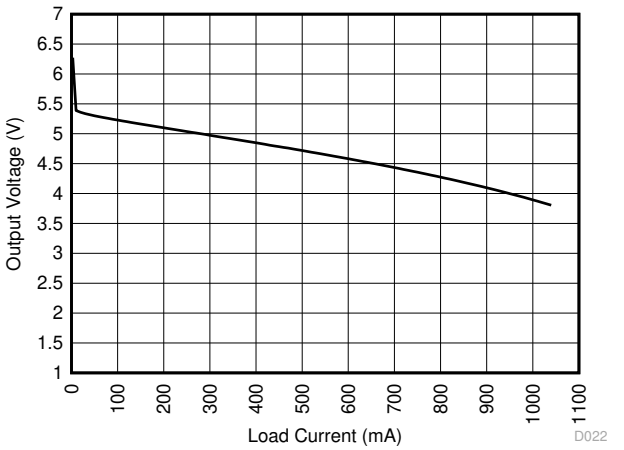
SN6505B/D-Q1 + Wurth 760390015 V_{CC} = 3.3 V

图 6-23. Output Voltage vs Load Current



SN6505B/D-Q1 + Wurth 760390015 V_{CC} = 3.3 V

图 6-24. Efficiency vs Load Current

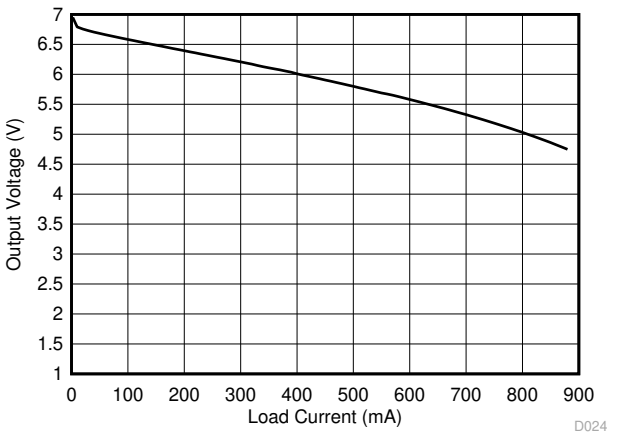


SN6505B/D-Q1 + Wurth 750316028 V_{CC} = 3.3 V

图 6-25. Output Voltage vs Load Current

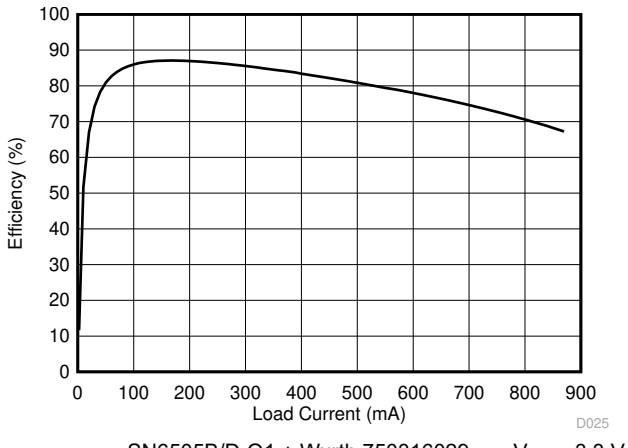
SN6505B/D-Q1 + Wurth 750316028 V_{CC} = 3.3 V

图 6-26. Efficiency vs Load Current



SN6505B/D-Q1 + Wurth 750316029 V_{CC} = 3.3 V

图 6-27. Output Voltage vs Load Current



SN6505B/D-Q1 + Wurth 750316029 V_{CC} = 3.3 V

图 6-28. Efficiency vs Load Current

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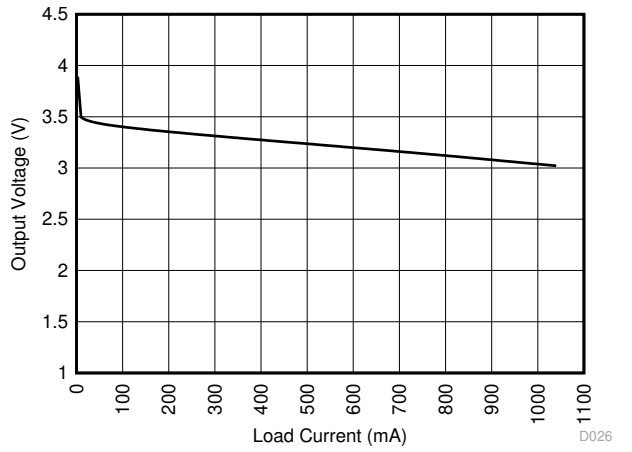

图 6-29. Output Voltage vs Load Current

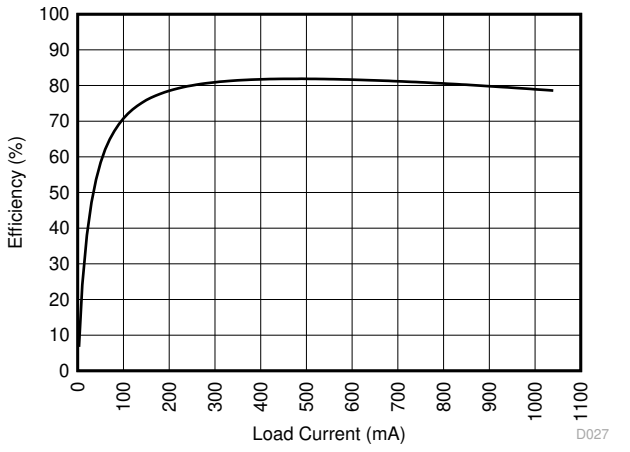

图 6-30. Efficiency vs Load Current

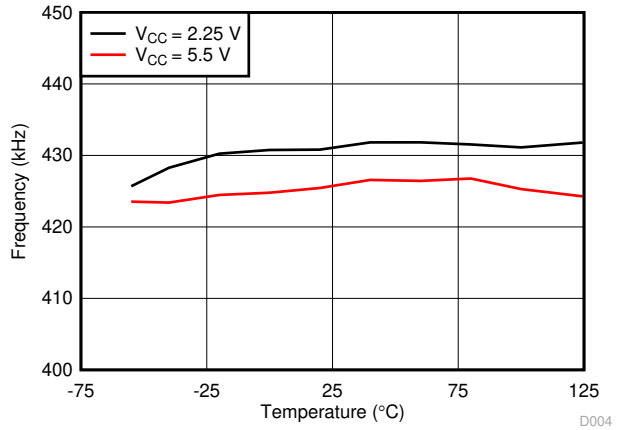

图 6-31. Frequency vs Free-Air Temperature

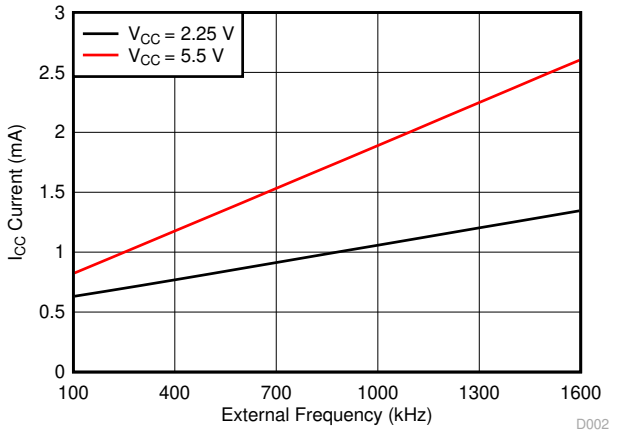

图 6-32. Current vs External Frequency

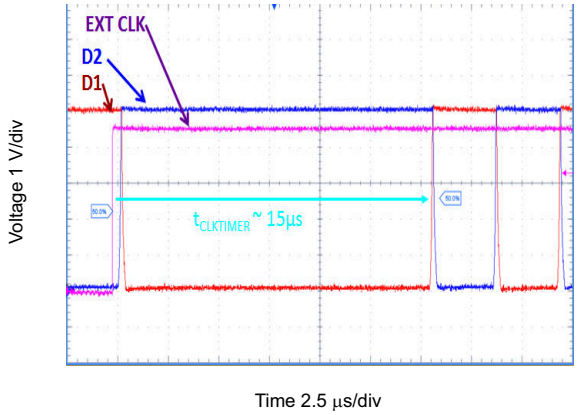

图 6-33. Scope Capture of SN6505 Switching from External to Internal Clock

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7 Parameter Measurement Information

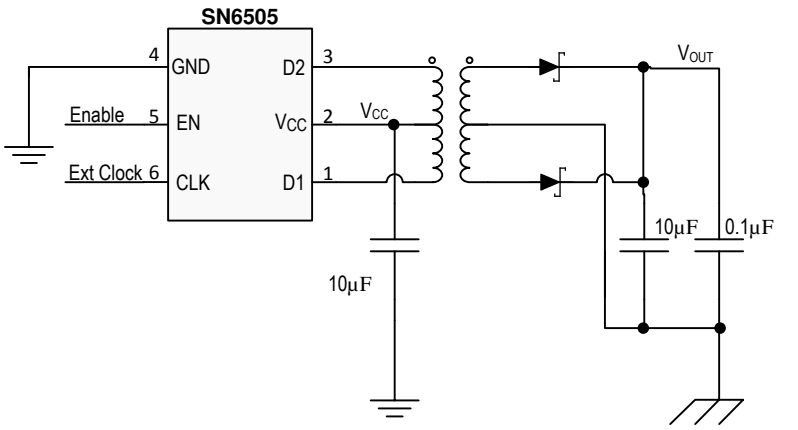

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图 7-1. Measurement Circuit for Unregulated Output (TP1)

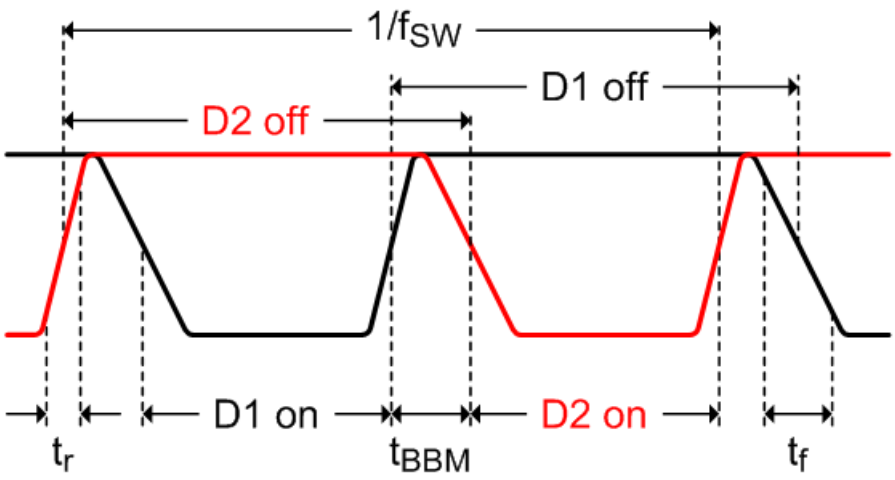

图 7-2. Timing Diagram

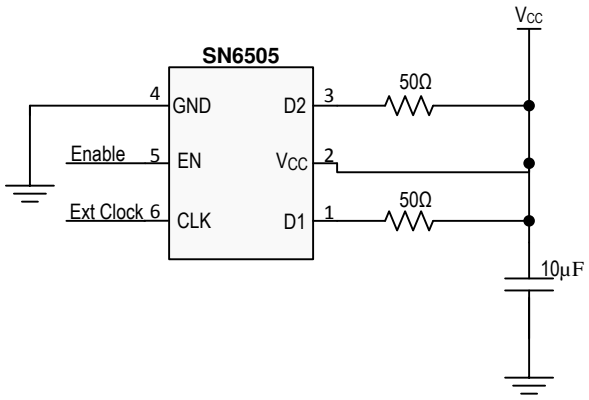

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图 7-3. Test Circuit for F_{SW}, $V_{(slew)}$, t_{BBM}

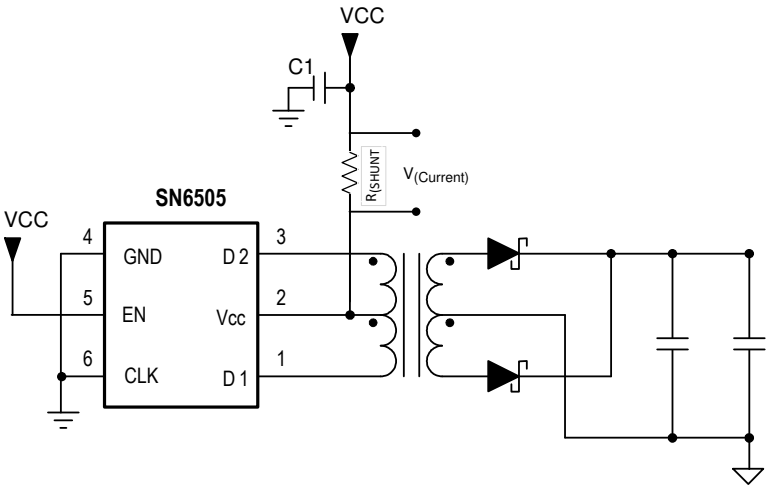

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图 7-4. $I_{(slew)}$ Test Setup

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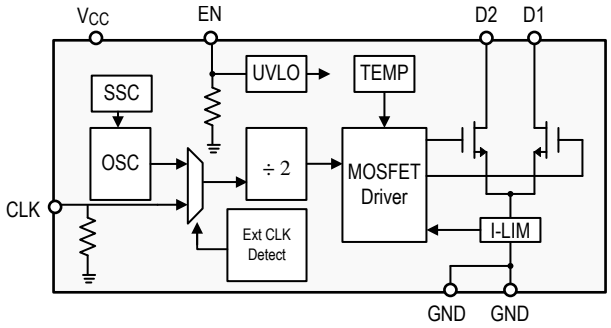
8 Detailed Description

8.1 Overview

The SN6505x-Q1 is a transformer driver designed for low-cost, small form-factor, isolated DC/DC converters utilizing the push-pull topology. The device includes an oscillator that feeds a gate-drive circuit. The gate-drive, comprising a frequency divider and a break-before-make (BBM) logic, provides two complementary output signals which alternately turn the two output transistors on and off.

The output frequency of the oscillator is divided down by two . A subsequent break-before-make logic inserts a dead-time between the high-pulses of the two signals. Before either one of the gates can assume logic high, the BBM logic ensures a short time period during which both signals are low and both transistors are high-impedance. This short period, is required to avoid shorting out both ends of the primary. The resulting output signals, present the gate-drive signals for the output transistors.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Push-Pull Converter

Push-pull converters require transformers with center-taps to transfer power from the primary to the secondary (see 图 8-1).

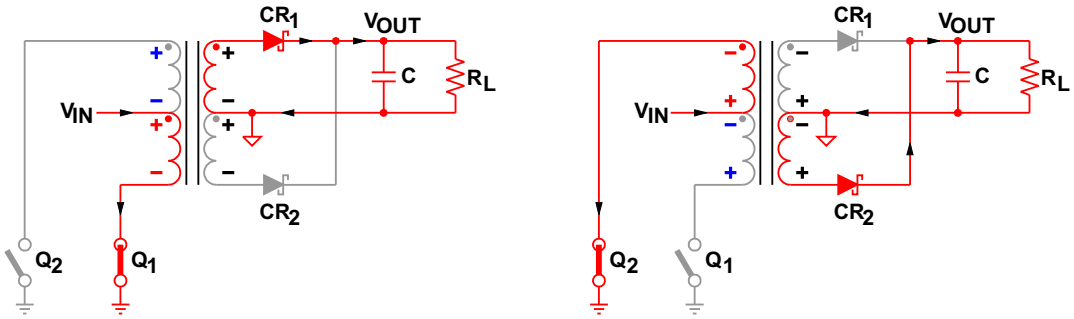


图 8-1. Switching Cycles of a Push-Pull Converter

When Q_1 conducts, V_{IN} drives a current through the lower half of the primary to ground, thus creating a negative voltage potential at the lower primary end with regards to the V_{IN} potential at the center-tap.

At the same time the voltage across the upper half of the primary is such that the upper primary end is positive with regards to the center-tap in order to maintain the previously established current flow through Q_2, which now has turned high-impedance. The two voltage sources, each of which equaling V_{IN}, appear in series and cause a voltage potential at the open end of the primary of $2 \times V_{IN}$ with regards to ground.

Per dot convention the same voltage polarities that occur at the primary also occur at the secondary. The positive potential of the upper secondary end therefore forward biases diode CR_1. The secondary current starting from the upper secondary end flows through CR_1, charges capacitor C, and returns through the load impedance R_L back to the center-tap.

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When Q_2 conducts, Q_1 goes high-impedance and the voltage polarities at the primary and secondary reverse. Now the lower end of the primary presents the open end with a $2\times V_{IN}$ potential against ground. In this case CR_2 is forward biased while CR_1 is reverse biased and current flows from the lower secondary end through CR_2, charging the capacitor and returning through the load to the center-tap.

8.3.2 Core Magnetization

图 8-2 shows the ideal magnetizing curve for a push-pull converter with B as the magnetic flux density and H as the magnetic field strength. When Q_1 conducts the magnetic flux is pushed from A to A' , and when Q_2 conducts the flux is pulled back from A' to A. The difference in flux and thus in flux density is proportional to the product of the primary voltage, V_P, and the time, t_{ON}, it is applied to the primary: $B \approx V_P \times t_{ON}$.

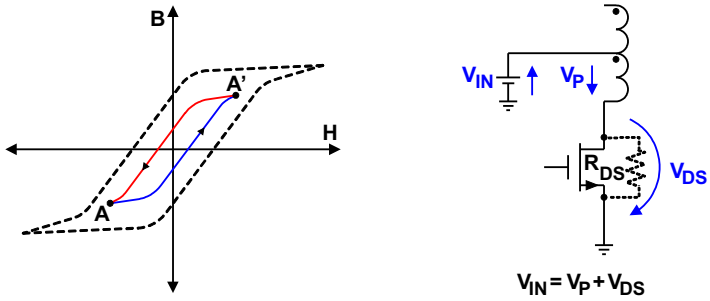

图 8-2. Core Magnetization and Self-Regulation Through Positive Temperature Coefficient of $R_{DS(on)}$

This volt-seconds (V-t) product is important as it determines the core magnetization during each switching cycle. If the V-t products of both phases are not identical, an imbalance in flux density swing results with an offset from the origin of the B-H curve. If balance is not restored, the offset increases with each following cycle and the transformer slowly creeps toward the saturation region.

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8.4 Device Functional Modes

The functional modes of the device are divided into start-up, operating, and off-mode.

8.4.1 Start-Up Mode

When the supply voltage at V_{CC} ramps up to 2.25 V , the internal oscillator starts operating . The output stage begins switching but the amplitude of the drain signals at D1 and D2 has not reached its full maximum yet.

8.4.1.1 Soft-Start

SN6505A-Q1 and SN6505B-Q1 devices support soft-start feature. Upon power up or when EN pin transitions from Low to High, the gate drive of the output power-MOSFET is gradually increased over a period of time from 0 V to V_{CC}. Soft-start prevents high inrush current from V_{CC} while charging large secondary side decoupling capacitors, and also prevents overshoot in secondary voltage during power-up. For applications that need quick power-up, the SN6505D-Q1, that has soft-start disabled, can be used.

8.4.2 Operating Mode

When the device supply has reached its nominal value ±10% the oscillator is fully operating. However variations over supply voltage and operating temperature can vary the switching frequencies at D1 and D2.

8.4.3 Shutdown-Mode

The device has a dedicated enable pin to put the device in very low power mode to save power when not in use. Enable pin has an internal pull down resistor which keeps device disabled when not driven. When disabled or when V_{CC} is < 1.7 V , both drain outputs, D1 and D2, are tri-stated.

8.4.4 Spread Spectrum Clocking

Radiated emissions is an important concern in high current switching power supplies. SN6505 addresses this by modulating its internal clock in such a way that the emitting energy is spread over multiple frequency bins. This Spread Spectrum clocking feature greatly improves the emissions performance of the entire power supply block and hence relieves the system designer from one major concern in isolated power supply design.

8.4.5 External Clock Mode

The SN6505x-Q1 has a CLK pin which can be used to synchronize the device with system clock and in turn with other SN6505x-Q1 devices so that the system can control the exact switching frequency of the device. The Rising edge of the CLK is used to divide a clock by two and used to drive the gates. 图 9-2 shows the timing diagram for the same. The device also has external clock fail safe feature which automatically switches the device to the internal clock if a valid input clock is not present for long ($t_{CLKTIMER}$). The in-built emissions reduction scheme of Spread Spectrum clocking is disabled when external clock is present.

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9 Application and Implementation

备注

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9.1 Application Information

The SN6505x-Q1 is a transformer driver designed for low-cost, small form-factor, isolated DC/DC converters using the push-pull topology. The device includes an oscillator that feeds a gate-drive circuit. The gate-drive, comprising a frequency divider and a break-before-make (BBM) logic, provides two complementary output signals which alternately turn the two output transistors on and off.

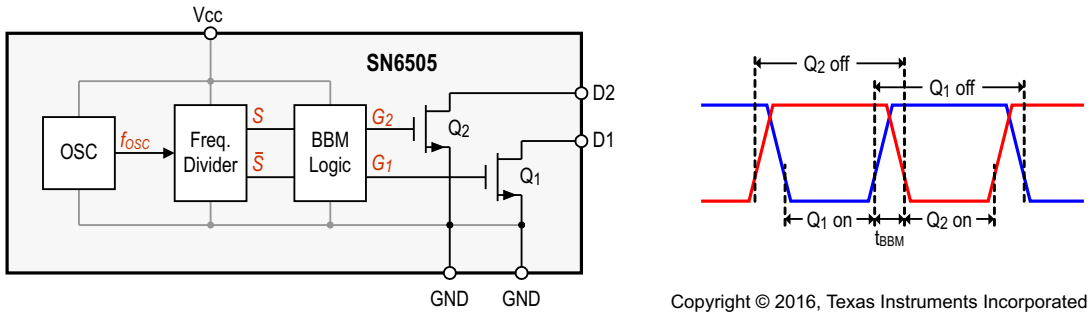

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图 9-1. Block Diagram and Output Timing With Break-Before-Make Action

The output frequency of the oscillator is divided down by an asynchronous divider that provides two complementary output signals, S and $\overline{S}$, with a 50% duty cycle. A subsequent break-before-make logic inserts a dead-time between the high-pulses of the two signals. The resulting output signals, G_1 and G_2, present the gate-drive signals for the output transistors Q_1 and Q_2. As shown in 图 9-2, before either one of the gates can assume logic high, there must be a short time period during which both signals are low and both transistors are high-impedance. This short period, known as break-before-make time, is required to avoid shorting out both ends of the primary.

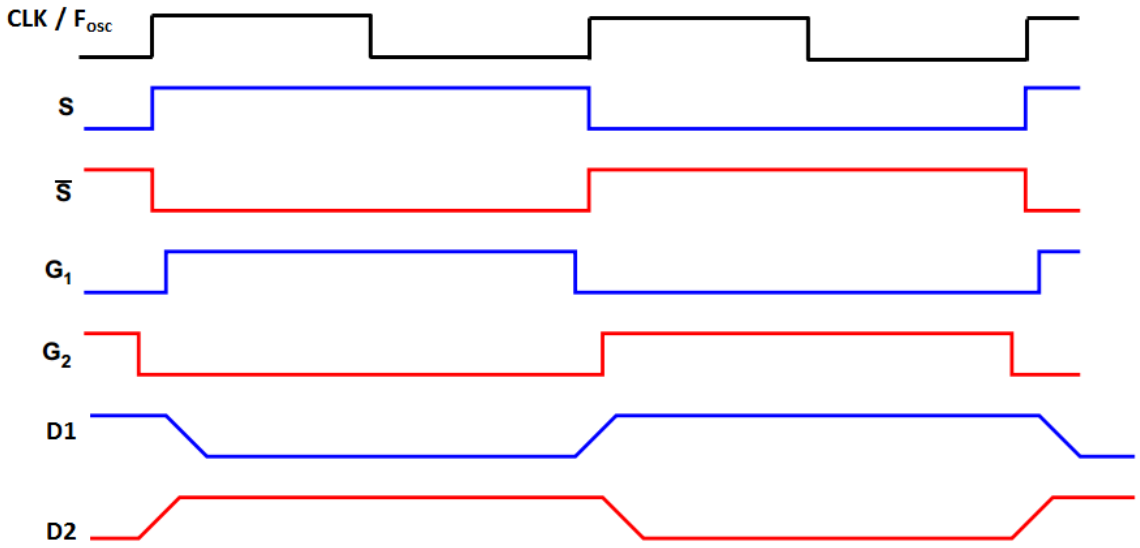

图 9-2. Detailed Output Signal Waveforms

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9.2 Typical Application

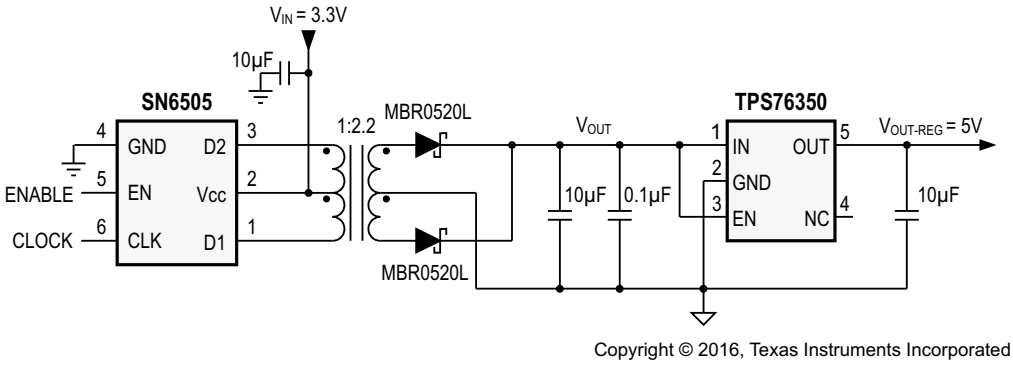

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图 9-3. Typical Application Schematic

9.2.1 Design Requirements

For this design example, use the parameters listed in 表 9-1 as design parameters.

表 9-1. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Input voltage range	3.3 V ± 3%
Output voltage	5 V
Maximum load current	100 mA

9.2.2 Detailed Design Procedure

The following recommendations on components selection focus on the design of an efficient push-pull converter with high current drive capability. Contrary to popular belief, the output voltage of the unregulated converter output drops significantly over a wide range in load current. The characteristic curve in 图 6-1 and 图 6-11 for example, shows that the difference between V_{OUT} at minimum load and V_{OUT} at maximum load exceeds a transceiver’s supply range. Therefore, in order to provide a stable, load independent supply while maintaining maximum possible efficiency the implementation of a low dropout regulator (LDO) is strongly advised.

The final converter circuit is shown in 图 9-8. The measured V_{OUT} and efficiency characteristics for the regulated and unregulated outputs are shown in 图 6-2 and 图 6-12.

9.2.2.1 Drive Capability

The transformer driver is designed for low-power push-pull converters with input and output voltages in the range of 2.25 V to 5.5 V. While converter designs with higher output voltages are possible, care must be taken that higher turns ratios don’t lead to primary currents that exceed the specified current limits of the device.

9.2.2.2 LDO Selection

The minimum requirements for a suitable low dropout regulator are:

- Its current drive capability should slightly exceed the specified load current of the application to prevent the LDO from dropping out of regulation. Therefore, for a load current of 600 mA, choose a 600 mA to 750 mA LDO. While regulators with higher drive capabilities are acceptable, they also usually possess higher dropout voltages that will reduce overall converter efficiency.
- The internal dropout voltage, V_{DO}, at the specified load current should be as low as possible to maintain efficiency. For a low-cost 750 mA LDO, a V_{DO} of 600 mV at 750 mA is common. Be aware; however, that this lower value is usually specified at room temperature and can increase by a factor of 2 over temperature, which in turn will raise the required minimum input voltage.
- The required minimum input voltage preventing the regulator from dropping out of line regulation is given with:

$$V_{I\text{-}min} = V_{DO\text{-}max} + V_{O\text{-}max} \quad (1)$$

This means in order to determine V_I for worst-case condition, the user must take the maximum values for V_{DO} and V_O specified in the LDO data sheet for rated output current (that is, 600 mA) and add them together. Also specify that the output voltage of the push-pull rectifier at the specified load current is equal or higher than $V_{I\text{-}min}$. If it is not, the LDO will lose line-regulation and any variations at the input passes straight through to the output. Hence, below $V_{I\text{-}min}$ the output voltage follows the input and the regulator behaves like a simple conductor.

- The maximum regulator input voltage must be higher than the rectifier output under no-load. Under this condition there is no secondary current reflected back to the primary, thus making the voltage drop across $R_{DS\text{-}on}$ negligible and allowing the entire converter input voltage to drop across the primary. At this point, the secondary reaches its maximum voltage of

$$V_{S\text{-}max} = V_{IN\text{-}max} \times n \quad (2)$$

with $V_{IN\text{-}max}$ as the maximum converter input voltage and n as the transformer turns ratio. Thus to prevent the LDO from damage the maximum regulator input voltage must be higher than $V_{S\text{-}max}$. 表 9-2 lists the maximum secondary voltages for various turns ratios commonly applied in push-pull converters.

表 9-2. Required Maximum LDO Input Voltages for Various Push-Pull Configurations

PUSH-PULL CONVERTER				LDO
CONFIGURATION	$V_{IN\text{-}max}$ [V]	TURNS-RATIO	$V_{S\text{-}max}$ [V]	$V_{I\text{-}max}$ [V]
3.3 V_{IN} to 3.3 V_{OUT}	3.6	1.5 ± 3%	5.6	6 to 10
3.3 V_{IN} to 5 V_{OUT}	3.6	2.2 ± 3%	8.2	10
5 V_{IN} to 5 V_{OUT}	5.5	1.5 ± 3%	8.5	10

9.2.2.3 Diode Selection

A rectifier diode should always possess low-forward voltage to provide as much voltage to the converter output as possible. When used in high-frequency switching applications, such as the SN6505x-Q1 however, the diode must also possess a short recovery time. Schottky diodes meet both requirements and are therefore strongly recommended in push-pull converter designs. A good choice for low-volt applications and ambient temperatures of up to 85°C is the low-cost Schottky rectifier MBR0520L with a typical forward voltage of 275 mV at 100-mA forward current. For higher output voltages such as ±10 V and above use the MBR0530 which provides a higher DC blocking voltage of 30 V.

Lab measurements have shown that at temperatures higher than 100°C the leakage currents of the above Schottky diodes increase significantly. This can cause thermal runaway leading to the collapse of the rectifier output voltage. Therefore, for ambient temperatures higher than 85°C use low-leakage Schottky diodes, such as RB168MM-40.

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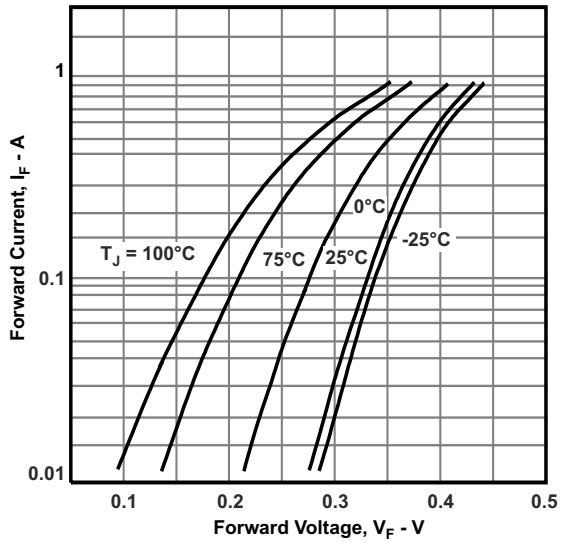

图 9-4. Diode Forward Characteristics for MBR0520L

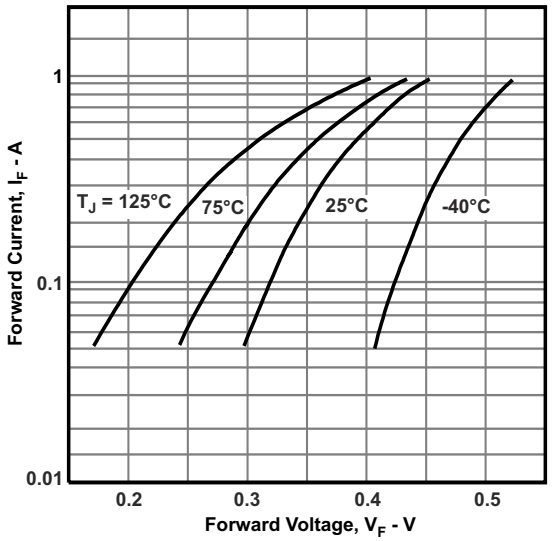

图 9-5. Diode Forward Characteristics MBR0530

9.2.2.4 Capacitor Selection

The capacitors in the converter circuit in 图 9-8 are multi-layer ceramic chip (MLCC) capacitors.

As with all high speed CMOS ICs, the device requires a bypass capacitor in the range of 10 nF to 100 nF.

The input bulk capacitor at the center-tap of the primary supports large currents into the primary during the fast switching transients. For minimum ripple make this capacitor 1 μF to 10 μF. In a 2-layer PCB design with a dedicated ground plane, place this capacitor close to the primary center-tap to minimize trace inductance. In a 4-layer board design with low-inductance reference planes for ground and V_{IN}, the capacitor can be placed at the supply entrance of the board. To ensure low-inductance paths use two vias in parallel for each connection to a reference plane or to the primary center-tap.

The bulk capacitor at the rectifier output smooths the output voltage. Make this capacitor 1 μF to 10 μF.

The small capacitor at the regulator input is not necessarily required. However, good analog design practice suggests, using a small value of 47 nF to 100 nF improves the regulator’s transient response and noise rejection.

The LDO output capacitor buffers the regulated output for the subsequent isolator and transceiver circuitry. The choice of output capacitor depends on the LDO stability requirements specified in the data sheet. However, in most cases, a low-ESR ceramic capacitor in the range of 4.7 μF to 10 μF will satisfy these requirements.

9.2.2.5 Transformer Selection

9.2.2.5.1 V-t Product Calculation

To prevent a transformer from saturation its V-t product must be greater than the maximum V-t product applied by the device. The maximum voltage delivered by the device is the nominal converter input plus 10%. The maximum time this voltage is applied to the primary is half the period of the lowest frequency at the specified input voltage. Therefore, the transformer’s minimum V-t product is determined through:

$$Vt_{min} \geq V_{IN\text{-}max} \times \frac{T_{max}}{2} = \frac{V_{IN\text{-}max}}{2 \times f_{min}} \tag{3}$$

Taking an example of f_{min} as 138 kHz for SN6505A-Q1 and 363 kHZ for SN6505B-Q1 or SN6505D-Q1 with a 5 V supply, 方程式 3 yields the minimum V-t products of:

$$Vt_{min} \geq \frac{5.5\ V}{2 \times 138\ kHz} = 20\ V\mu s \quad \text{for SN6505A-Q1, and}$$

$$Vt_{min} \geq \frac{5.5\ V}{2 \times 363\ kHz} = 7.6\ V\mu s \quad \text{for SN6505B/D-Q1 applications.} \tag{4}$$

Common V-t values for low-power center-tapped transformers range from 22 V μs to 150 V μs with typical footprints of 10 mm x 12 mm. However, transformers specifically designed for PCMCIA applications provide as little as 11 V μs and come with a significantly reduced footprint of 6 mm x 6 mm only.

While Vt-wise all of these transformers can be driven by the device, other important factors such as isolation voltage, transformer wattage, and turns ratio must be considered before making the final decision.

9.2.2.5.2 Turns Ratio Estimate

Assume the rectifier diodes and linear regulator has been selected. Also, it has been determined that the transformer chosen must have a V-t product of at least 11 V μs. However, before searching the manufacturer web sites for a suitable transformer, the user still needs to know its minimum turns ratio that allows the push-pull converter to operate flawlessly over the specified current and temperature range. This minimum transformation

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ratio is expressed through the ratio of minimum secondary to minimum primary voltage multiplied by a correction factor that takes the transformer's typical efficiency of 97% into account:

$$V_{P\text{-}min} = V_{IN\text{-}min} - V_{DS\text{-}max} \quad (5)$$

$V_{S\text{-}min}$ must be large enough to allow for a maximum voltage drop, $V_{F\text{-}max}$, across the rectifier diode and still provide sufficient input voltage for the regulator to remain in regulation. From the *节 9.2.2.2* section, this minimum input voltage is known and by adding $V_{F\text{-}max}$ gives the minimum secondary voltage with:

$$V_{S\text{-}min} = V_{F\text{-}max} + V_{DO\text{-}max} + V_{O\text{-}max} \quad (6)$$

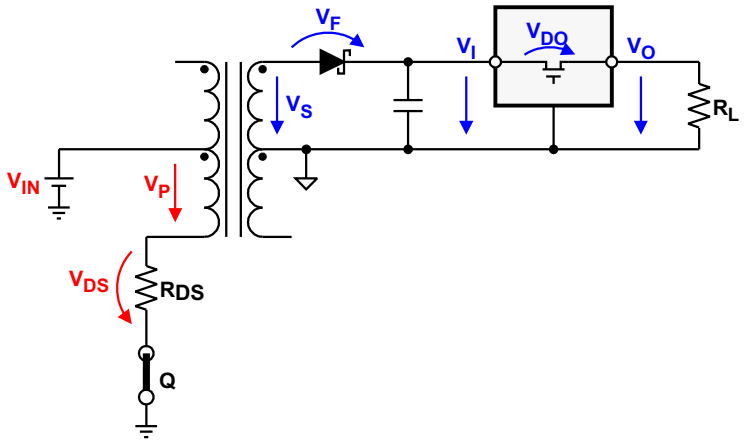

图 9-6. Establishing the Required Minimum Turns Ratio Through $N_{min} = 1.031 \times V_{S\text{-}min} / V_{P\text{-}min}$

Then calculating the available minimum primary voltage, $V_{P\text{-}min}$, involves subtracting the maximum possible drain-source voltage of the device, $V_{DS\text{-}max}$, from the minimum converter input voltage $V_{IN\text{-}min}$:

$$V_{P\text{-}min} = V_{IN\text{-}min} - V_{DS\text{-}max} \quad (7)$$

$V_{DS\text{-}max}$ however, is the product of the maximum $R_{DS(on)}$ and I_D values for a given supply specified in the data sheet:

$$V_{DS\text{-}max} = R_{DS\text{-}max} \times I_{Dmax} \quad (8)$$

Then inserting 方程式 8 into 方程式 7 yields:

$$V_{P\text{-}min} = V_{IN\text{-}min} - R_{DS\text{-}max} \times I_{Dmax} \quad (9)$$

and inserting 方程式 9 and 方程式 6 into 方程式 5 provides the minimum turns ration with:

$$n_{min} = 1.031 \times \frac{V_{F\text{-}max} + V_{DO\text{-}max} + V_{O\text{-}max}}{V_{IN\text{-}min} - R_{DS\text{-}max} \times I_{D\text{-}max}} \quad (10)$$

Example:

For a 3.3 V_{IN} to 5 V_{OUT} converter using the rectifier diode MBR0520L and the 5 V LDO, the data sheet values taken for a load current of 600 mA and a maximum temperature of 85°C are $V_{F\text{-}max}$ = 0.2 V, $V_{DO\text{-}max}$ = 0.5 V, and $V_{O\text{-}max}$ = 5.1 V.

Then assuming that the converter input voltage is taken from a 3.3 V controller supply with a maximum ±2% accuracy makes $V_{IN\text{-}min}$ = 3.234 V. Finally the maximum values for drain-source resistance and drain current at 3.3 V are taken from the data sheet with $R_{DS\text{-}max}$ = 0.31 Ω and $I_{D\text{-}max}$ = 1 A.

Inserting the values above into 方程式 10 yields a minimum turns ratio of:

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$$n_{min} = 1.031 \times \frac{0.2\ V + 0.5\ V + 5.1\ V}{3.234\ V - 0.31\ \Omega \times 1\ A} = 2.05 \quad (11)$$

Most commercially available transformers for 3-to-5 V push-pull converters offer turns ratios between 2.0 and 2.3 with a common tolerance of ±3%.

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9.2.2.5.3 Recommended Transformers

Depending on the application, use the minimum configuration in 图 9-7 or standard configuration in 图 9-8.

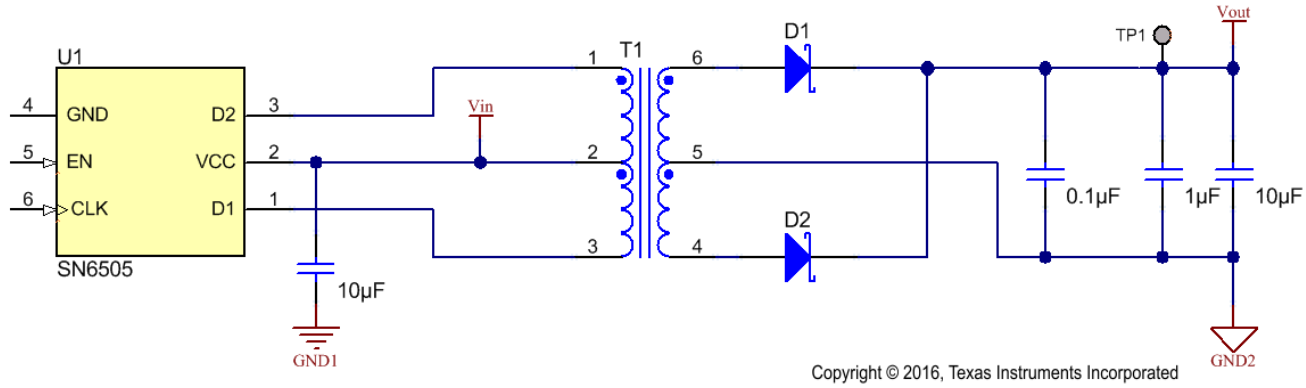

图 9-7. Unregulated Output for Low-Current Loads With Wide Supply Range

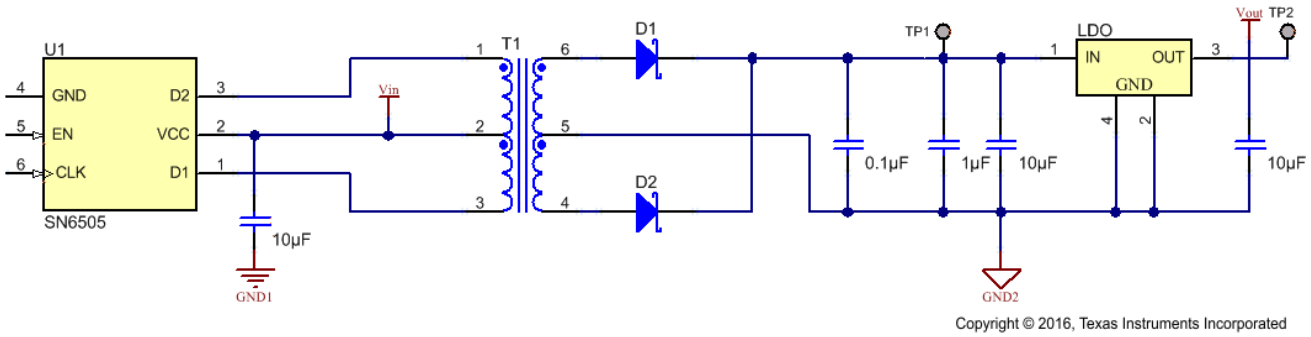

图 9-8. Regulated Output for Stable Supplies and High Current Loads

The Wurth Electronics Midcom isolation transformers in 表 9-3 are optimized designs for the device, providing high efficiency and small form factor at low-cost.

The 1:1.1 and 1:1.7 turns-ratios are designed for logic applications with wide supply rails and low load currents. These applications operate without LDO, thus achieving further cost-reduction.

表 9-3. Recommended Isolation Transformers Optimized for the Device

TURNS RATIO	V × T (V µ s)	ISOLATION (V_{RMS})	DIMENSIONS (mm)	APPLICATION	LDO(1)	ORDER NO.	MANUFACTURER
1:1.1 ±2%	7	2500	6.73 x 10.05 x 4.19	3.3 V → 3.3 V, 100mA, SN6505B/D-Q1 Refer to 图 6-13 and 图 6-14	No	760390011	Wurth Electronics / Midcom
1:1.1 ±2%	11			5 V → 5 V, 100mA, SN6505B/D-Q1 Refer to 图 6-15 and 图 6-16		760390012	
1:1.7 ±2%				3.3 V → 5 V, 100mA, SN6505B/D-Q1 Refer to 图 6-17 and 图 6-18		760390013	
1:1.3 ±2%				3.3 V → 3.3 V, 100mA, SN6505B/D-Q1 Refer to 图 6-19 and 图 6-20	Yes	760390014	
1:1.3 ±2%				5 V → 5 V, 100mA, SN6505B/D-Q1 Refer to 图 6-21 and 图 6-22		760390014	
1:2.1 ±2%				3.3 V → 5 V, 100mA, SN6505B/D-Q1 Refer to 图 6-23 and 图 6-24		760390015	
1.23:1 ±2%				5 V → 3.3 V, 100mA, SN6505B/D-Q1		750313710	
1:1.7 ±2%	8.9		8.3 x 12.6 x 4.1	3.3 V → 3.3 V, 1A, SN6505B/D-Q1 Refer to 图 6-25 and 图 6-26		750316028	
1:2.1 ±2%				3.3 V → 5 V, 1A, SN6505B/D-Q1 Refer to 图 6-27 and 图 6-28	No	750316029	
1.3:1 ±2%	10.8			5 V → 3.3 V, 1A, SN6505B/D-Q1 Refer to 图 6-29 and 图 6-30		750316030	
1:1.1 ±2%	8.6			3.3 V → 3.3 V , 1A , SN6505B/D-Q1 5 V → 5 V , 1A , SN6505B/D-Q1 Refer to 图 6-11 and 图 6-12		750315371	
1:1.1 ±2%	11	5000	9.14 x 12.7 x 7.37	3.3 V → 3.3 V, 100mA, SN6505B/D-Q1		750313734	
1:1.1 ±2%				5 V → 5 V, 100mA, SN6505B/D-Q1		750313734	
1:1.7 ±2%				3.3 V → 5 V, 100mA, SN6505B/D-Q1		750313769	
1:1.3 ±2%				3.3 V → 3.3 V, 100mA, SN6505B/D-Q1 5 V → 5 V, 100mA, SN6505B/D-Q1	Yes	750313638	
1:2.1 ±2%				3.3 V → 5 V, 100mA, SN6505B/D-Q1		750313626	
1.3:1 ±2%				5 V → 3.3 V, 100mA , SN6505B/D-Q1	No	750313638	
1:1.75 ±2%	41		12.32 x 15.41 x 11.05	3.3 V → 3.3 V, 1A, SN6505A-Q1 Refer to 图 6-3 and 图 6-4	Yes	750316031	
1:2 ±2%				3.3 V → 5 V, 1A, SN6505A-Q1 Refer to 图 6-5 and 图 6-6	No	750316032	
1.3:1 ±2%	42			5.0 V → 3.3 V, 1A, SN6505A-Q1 Refer to 图 6-7 and 图 6-8		750316033	
1:1.1 ±2%	23		12.32 x 15.41 x 11.89	3.3 V → 3.3 V, 1A, SN6505A-Q1 5 V → 5 V, 1A , SN6505A-Q1 Refer to 图 6-1 and 图 6-2		750315240	
1:1.3 ±3%	11	5000	10.4 x 12.2 x 6.1	3.3 V → 3.3 V, 300mA, SN6505B/D-Q1 5 V → 5 V, 300mA , SN6505B/D-Q1	No	HCT-SM-1.3-8-2	Bourns
1:1.5 ±3%	34.4	2500	10 x 12.07 x 5.97	3.3 V → 3.3 V, 1A, SN6505A/B/D-Q1 5 V → 5 V, 1A , SN6505A/B/D-Q1	Yes	DA2303-AL	Coilcraft
1:2.2 ±3%	21.5	2500	10 x 12.07 x 5.97	3.3 V → 5 V, 1A, SN6505A/B/D-Q1		DA2304-AL	

(1) For configurations with LDO, a higher voltage than the required output voltage is generated, to allow for LDO drop-out. Figures show the voltage and efficiency at the LDO input.

9.2.3 Application Curves

See the 节 6.7 and 节 6.8 for application curves with transformers optimized for the device, providing high efficiency and small form factor at low-cost.

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9.2.4 System Examples

9.2.4.1 Higher Output Voltage Designs

The device can drive push-pull converters that provide high output voltages of up to 30 V, or bipolar outputs of up to ±15 V. Using commercially available center-tapped transformers, with their rather low turns ratios of 0.8 to 5, requires different rectifier topologies to achieve high output voltages. 图 9-9 to 图 9-11 show some of these topologies together with their respective open-circuit output voltages.

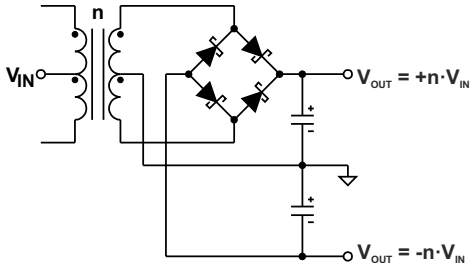

图 9-9. Bridge Rectifier With Center-Tapped Secondary Enables Bipolar Outputs

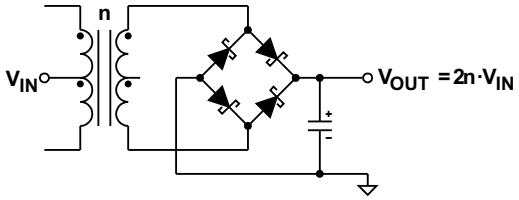

图 9-10. Bridge Rectifier Without Center-Tapped Secondary Performs Voltage Doubling

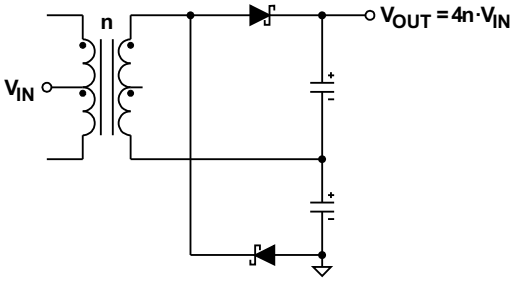

图 9-11. Half-Wave Rectifier Without Centered Ground and Center-Tapped Secondary Performs Voltage Doubling Twice, Hence Quadrupling V_{IN}

9.2.4.2 Application Circuits

The following application circuits are shown for a 3.3 V input supply commonly taken from the local, regulated microcontroller supply. For 5 V input voltages requiring different turn ratios refer to the transformer manufacturers and their web sites listed in 表 9-4.

表 9-4. Transformer Manufacturers

MANUFACTURER	MORE INFORMATION
Coilcraft Inc.	http://www.coilcraft.com
Halo-Electronics Inc.	http://www.haloelectronics.com
Murata Power Solutions	http://www.murata-ps.com
Wurth Electronics Midcom Inc	http://www.midcom-inc.com

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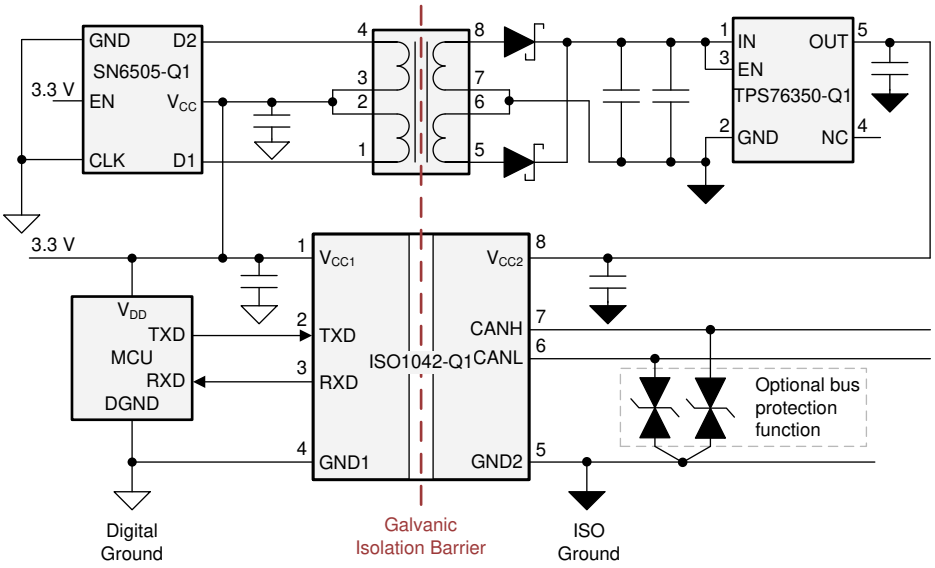

图 9-12. Isolated CAN Interface

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10 Power Supply Recommendations

The device is designed to operate from an input voltage supply range between 2.5 V and 5 V nominal. This input supply must be regulated within ±10%. If the input supply is located more than a few inches from the device, a 0.1 μF by-pass capacitor should be connected as close as possible to the device V_{CC} pin and a 10 μF capacitor should be connected close to the transformer center-tap pin.

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11 Layout

11.1 Layout Guidelines

- The V_{IN} pin must be buffered to ground with a low-ESR ceramic bypass-capacitor. The recommended capacitor value can range from 1 μF to 10 μF. The capacitor must have a voltage rating of 10 V minimum and a X5R or X7R dielectric.
- The optimum placement is closest to the V_{IN} and GND pins at the board entrance to minimize the loop area formed by the bypass-capacitor connection, the V_{IN} terminal, and the GND pin. See 图 11-1 for a PCB layout example.
- The connections between the device D1 and D2 pins and the transformer primary endings, and the connection of the device V_{CC} pin and the transformer center-tap must be as close as possible for minimum trace inductance.
- The connection of the device V_{CC} pin and the transformer center-tap must be buffered to ground with a low-ESR ceramic bypass-capacitor. The recommended capacitor value can range from 1 μF to 10 μF. The capacitor must have a voltage rating of 16 V minimum and a X5R or X7R dielectric.
- The device GND pins must be tied to the PCB ground plane using two vias for minimum inductance.
- The ground connections of the capacitors and the ground plane should use two vias for minimum inductance.
- The rectifier diodes should be Schottky diodes with low forward voltage in the 10 mA to 100 mA current range to maximize efficiency.
- The V_{OUT} pin must be buffered to ISO-Ground with a low-ESR ceramic bypass-capacitor. The recommended capacitor value can range from 1 μF to 10 μF. The capacitor must have a voltage rating of 16 V minimum and a X5R or X7R dielectric.

11.2 Layout Example

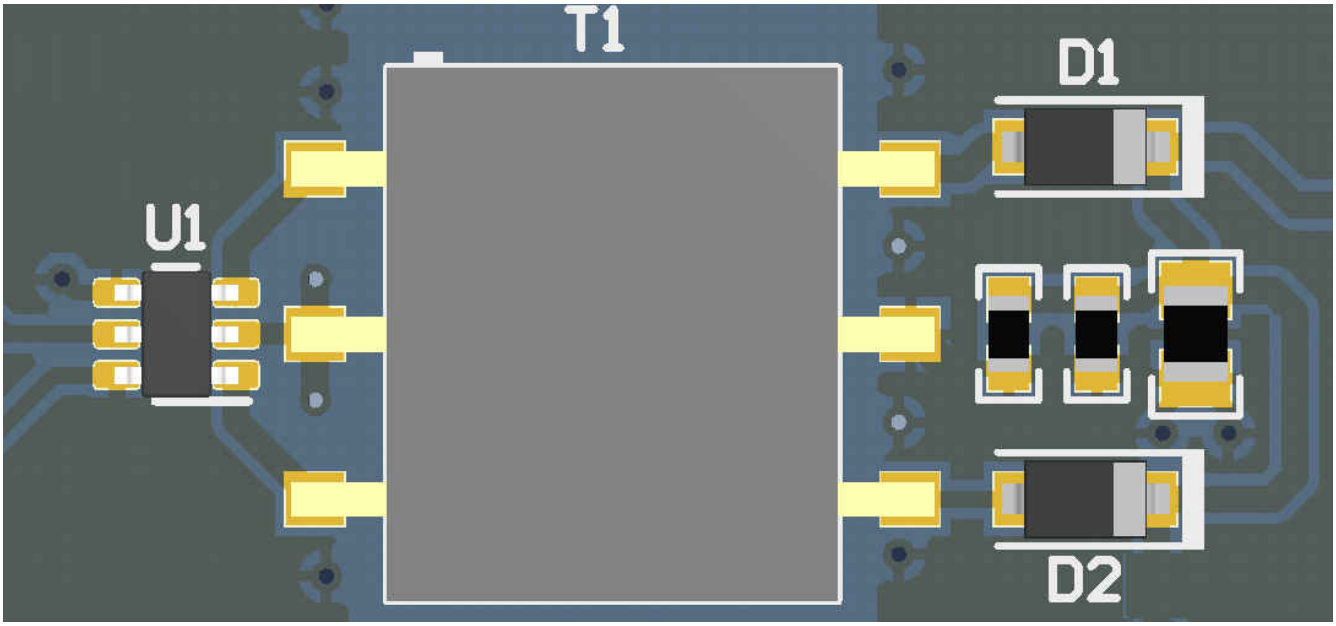

图 11-1. Layout Example of a 2-Layer Board

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12 Device and Documentation Support

12.1 Device Support

12.1.1 第三方产品免责声明

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12.2 Documentation Support

12.2.1 Related Documentation

For related documentation see the following:

- Texas Instruments, *Digital Isolator Design Guide*
- Texas Instruments, *Isolation Glossary*
- Texas Instruments, *How to Isolate Signal and Power in Isolated CAN Systems* TI TechNote
- Texas Instruments, *Small Form-Factor Reinforced Isolated IGBT Gate Drive Reference Design for 3-Phase Inverter* TI Design

12.3 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to order now.

表 12-1. Related Links

PARTS	PRODUCT FOLDER	ORDER NOW	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
SN6505A-Q1	Click here	Click here	Click here	Click here	Click here
SN6505B-Q1	Click here	Click here	Click here	Click here	Click here
SN6505D-Q1	Click here	Click here	Click here	Click here	Click here

12.4 接收文档更新通知

要接收文档更新通知，请导航至 ti.com 上的器件产品文件夹。点击 *订阅更新* 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

12.5 支持资源

TI E2E™ 支持论坛是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《使用条款》。

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ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

12.8 术语表

TI 术语表　　本术语表列出并解释了术语、首字母缩略词和定义。

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13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN6505AQDBVRQ1	ACTIVE	SOT-23	DBV	6	3000	RoHS & Green	NIPDAU | NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	65AQ	Samples
SN6505AQDBVTQ1	ACTIVE	SOT-23	DBV	6	250	RoHS & Green	NIPDAU | NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	65AQ	Samples
SN6505BQDBVRQ1	ACTIVE	SOT-23	DBV	6	3000	RoHS & Green	NIPDAU | NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	65BQ	Samples
SN6505BQDBVTQ1	ACTIVE	SOT-23	DBV	6	250	RoHS & Green	NIPDAU | NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	65BQ	Samples
SN6505DQDBVRQ1	ACTIVE	SOT-23	DBV	6	3000	RoHS & Green	NIPDAU | NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	65DQ	Samples
SN6505DQDBVTQ1	ACTIVE	SOT-23	DBV	6	250	RoHS & Green	NIPDAU | NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	65DQ	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN6505A-Q1, SN6505B-Q1 :

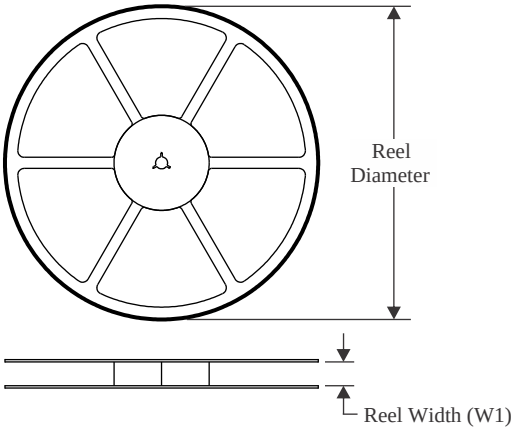
- Catalog : SN6505A, SN6505B

NOTE: Qualified Version Definitions:

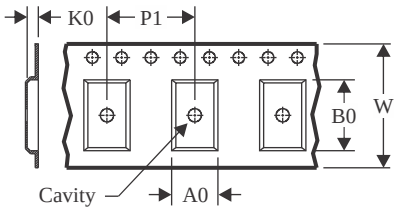
- Catalog - TI's standard catalog product

TAPE AND REEL INFORMATION

REEL DIMENSIONS

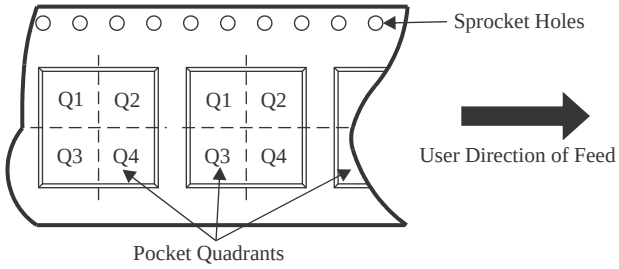


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

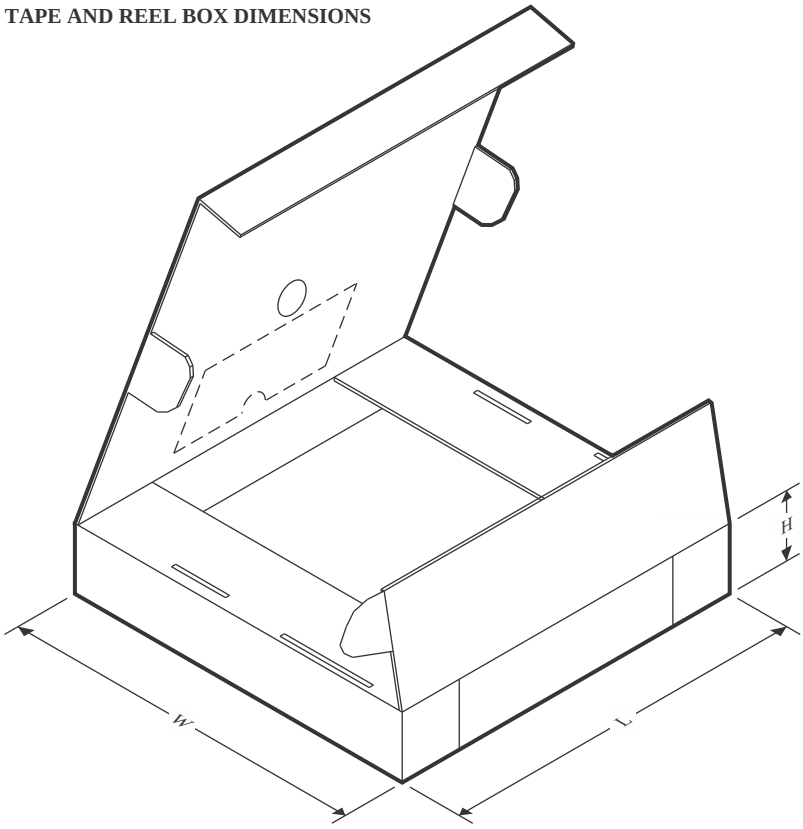
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN6505AQDBVRQ1	SOT-23	DBV	6	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
SN6505AQDBVTQ1	SOT-23	DBV	6	250	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
SN6505BQDBVRQ1	SOT-23	DBV	6	3000	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
SN6505BQDBVRQ1	SOT-23	DBV	6	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
SN6505BQDBVTQ1	SOT-23	DBV	6	250	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
SN6505DQDBVRQ1	SOT-23	DBV	6	3000	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
SN6505DQDBVRQ1	SOT-23	DBV	6	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
SN6505DQDBVTQ1	SOT-23	DBV	6	250	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

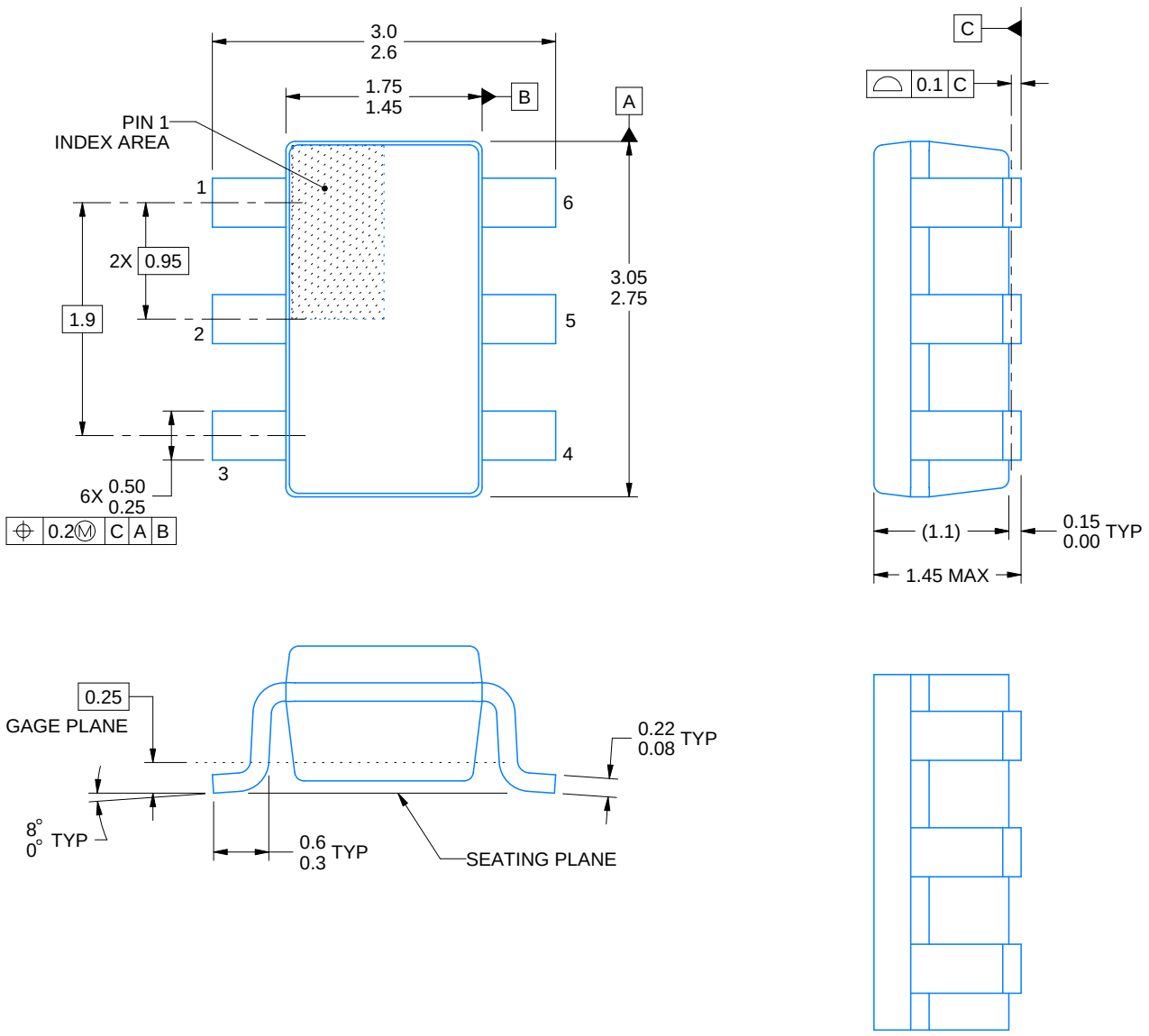
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN6505AQDBVRQ1	SOT-23	DBV	6	3000	210.0	185.0	35.0
SN6505AQDBVTQ1	SOT-23	DBV	6	250	210.0	185.0	35.0
SN6505BQDBVRQ1	SOT-23	DBV	6	3000	213.0	191.0	35.0
SN6505BQDBVRQ1	SOT-23	DBV	6	3000	210.0	185.0	35.0
SN6505BQDBVTQ1	SOT-23	DBV	6	250	210.0	185.0	35.0
SN6505DQDBVRQ1	SOT-23	DBV	6	3000	213.0	191.0	35.0
SN6505DQDBVRQ1	SOT-23	DBV	6	3000	210.0	185.0	35.0
SN6505DQDBVTQ1	SOT-23	DBV	6	250	210.0	185.0	35.0

PACKAGE OUTLINE

DBV0006A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



ALTERNATIVE PACKAGE SINGULATION VIEW

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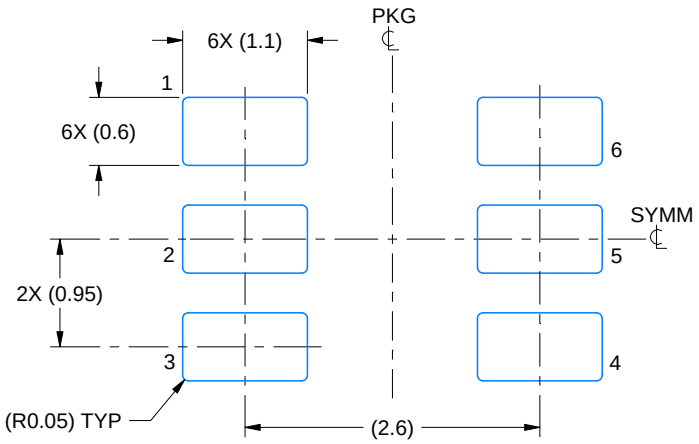
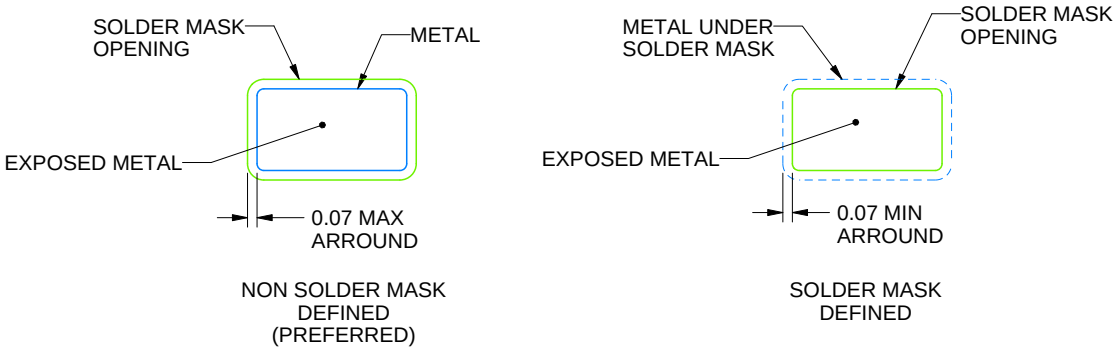
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.25 per side.
4. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
5. Refernce JEDEC MO-178.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

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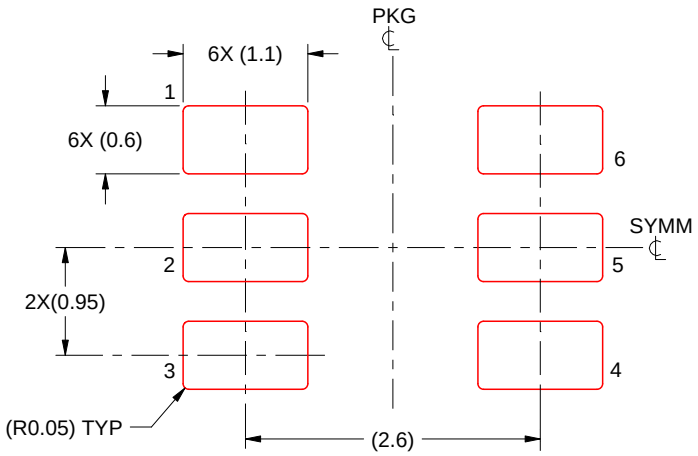
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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